

Quad-Core Intel® Xeon® Processor 5400 Series

Thermal/Mechanical Design Guidelines

November 2007



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Revision History

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318611	001	Initial release of the document.	November 2007

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1 Introduction

1.1 Objective

The purpose of this guide is to describe the reference thermal solution and design parameters required for the Quad-Core Intel® Xeon® Processor 5400 Series.

It is also the intent of this document to comprehend and demonstrate the processor cooling solution features and requirements. Furthermore, this document provides an understanding of the processor thermal characteristics, and discusses guidelines for meeting the thermal requirements imposed over the entire life of the processor. The thermal/mechanical solutions described in this document are intended to aid component and system designers in the development and evaluation of processor compatible thermal/mechanical solutions.

1.2 Scope

The thermal/mechanical solutions described in this document pertain to a solution(s) intended for use with the Quad-Core Intel® Xeon® Processor 5400 Series in 1U, 2U, 2U+ and workstation form factors systems. This document contains the mechanical and thermal requirements of the processor cooling solution. In case of conflict, the data in the *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet* supersedes any data in this document. Additional information is provided as a reference in the appendices.

1.3 References

Material and concepts available in the following documents may be beneficial when reading this document.

Table 1-1. Reference Documents (Sheet 1 of 2)

Document	Comment
<i>European Blue Angel Recycling Standards</i>	http://www.blauer-engel.de
<i>Intel® Xeon® Dual- and Multi- Processor Family Thermal Test Vehicle User's Guide</i>	See Note at bottom table.
<i>LGA771 Socket Mechanical Design Guide</i>	See Note following table.
<i>LGA771 SMT Socket Design Guidelines</i>	See Note following table.
<i>LGA771 Daisy Chain Test Vehicle User Guide</i>	See Note following table.
<i>Stoakley Platform Design Guide (PDG)</i>	See Note following table.
<i>Dual-Core Intel® Xeon® Processor-Based Servers Platform Design Guide (PDG)</i>	See Note following table.
<i>Dual-Core Intel® Xeon® Processor-Based Workstation Platform Design Guide (PDG)</i>	See Note following table.
<i>Clovertown, Harpertown & Wolfdale-DP Processors Compatibility Design Guide for Bensley, Bensley-VS, and Glidewell Platforms</i>	See Note following table.
<i>PECI Feature Set Overview</i>	See Note following table
<i>Platform Environment Control Interface(PECI) Specification</i>	See Note following table
<i>Quad-Core Intel® Xeon® Processor 5400 Series Datasheet</i>	See Note following table.
<i>Clovertown_Harpertown_Wolfdale-DP Processor Enabled CEK and Package Mechanical Models</i> (in IGES and ProE* format)	Available electronically



Table 1-1. Reference Documents (Sheet 2 of 2)

Document	Comment
<i>Clovertown_Harpertown_Wolfdale-DP Processor Enabled Components CEK Thermal Models</i> (in Flotherm* and Icepak*)	Available electronically
<i>Clovertown_Harpertown_Wolfdale-DP Processor Package Thermal Models</i> (in Flotherm and Icepak)	Available electronically
<i>RS - Wolfdale Processor Family BIOS Writers Guide (BWG)</i>	See Note following table.
<i>Thin Electronics Bay Specification (A Server System Infrastructure (SSI) Specification for Rack Optimized Servers)</i>	www.ssiforum.com

Note: Contact your Intel field sales representative for the latest revision and order number of this document.

1.4 Definition of Terms

Table 1-2. Terms and Descriptions (Sheet 1 of 2)

Term	Description
Bypass	Bypass is the area between a passive heatsink and any object that can act to form a duct. For this example, it can be expressed as a dimension away from the outside dimension of the fins to the nearest surface.
DTS	Digital Thermal Sensor replaces the Tdiode in previous products and uses the same sensor as the PROCHOT# sensor to indicate the on-die temperature. The temperature value represents the number of degrees below the TCC activation temperature.
MSR	The processor provides a variety of model specific registers that are used to control and report on processor performance. Virtually all MSRs handle system related functions and are not accessible to an application program.
FMB	Flexible Motherboard Guideline: an estimate of the maximum value of a processor specification over certain time periods. System designers should meet the FMB values to ensure their systems are compatible with future processor releases.
FSC	Fan Speed Control
IHS	Integrated Heat Spreader: a component of the processor package used to enhance the thermal performance of the package. Component thermal solutions interface with the processor at the IHS surface.
LGA771 Socket	The Quad-Core Intel® Xeon® Processor 5400 Series interfaces to the baseboard through this surface mount, 771 Land socket. See the <i>LGA771 Socket Mechanical Design Guide</i> for details regarding this socket.
P _{MAX}	The maximum power dissipated by a semiconductor component.
PECI	A proprietary one-wire bus interface that provides a communication channel between Intel processor and chipset components to external thermal monitoring devices, for use in fan speed control. Peci communicates readings from the processors Digital Thermal Sensor. Peci replaces the thermal diode available in previous processors.
Ψ _{CA}	Case-to-ambient thermal characterization parameter (psi). A measure of thermal solution performance using total package power. Defined as (T _{CASE} - T _{LA}) / Total Package Power. Heat source should always be specified for Ψ measurements.
Ψ _{CS}	Case-to-sink thermal characterization parameter. A measure of thermal interface material performance using total package power. Defined as (T _{CASE} - T _S) / Total Package Power.
Ψ _{SA}	Sink-to-ambient thermal characterization parameter. A measure of heatsink thermal performance using total package power. Defined as (T _S - T _{LA}) / Total Package Power.
T _{CASE}	The case temperature of the processor, measured at the geometric center of the topside of the IHS.
T _{CASE_MAX}	The maximum case temperature as specified in a component specification.
TCC	Thermal Control Circuit: Thermal monitor uses the TCC to reduce the die temperature by using clock modulation and/or operating frequency and input voltage adjustment when the die temperature is very near its operating limits.



Table 1-2. Terms and Descriptions (Sheet 2 of 2)

T_{CONTROL}	A processor unique value for use in fan speed control mechanisms. T_{CONTROL} is a temperature specification based on a temperature reading from the processor's Digital Thermal Sensor. T_{CONTROL} can be described as a trigger point for fan speed control implementation. $T_{\text{CONTROL}} = -T_{\text{OFFSET}}$.
T_{OFFSET}	An offset value from the TCC activation temperature value programmed into each processor during manufacturing and can be obtained by reading the IA_32_TEMPERATURE_TARGET MSR. This is a static and a unique value. Refer to the <i>RS - Wolfdale Processor Family BIOS Writers Guide (BWG)</i> for further details.
TDP	Thermal Design Power: Thermal solution should be designed to dissipate this target power level. TDP is not the maximum power that the processor can dissipate.
Thermal Monitor	A feature on the processor that can keep the processor's die temperature within factory specifications under normal operating conditions.
Thermal Profile	Line that defines case temperature specification of a processor at a given power level.
TIM	Thermal Interface Material: The thermally conductive compound between the heatsink and the processor case. This material fills the air gaps and voids, and enhances the transfer of the heat from the processor case to the heatsink.
T_{LA}	The measured ambient temperature locally surrounding the processor. The ambient temperature should be measured just upstream of a passive heatsink or at the fan inlet for an active heatsink.
T_{SA}	The system ambient air temperature external to a system chassis. This temperature is usually measured at the chassis air inlets.
U	A unit of measure used to define server rack spacing height. 1U is equal to 1.75 in, 2U equals 3.50 in, etc.





2 Thermal/Mechanical Reference Design

This chapter describes the thermal/mechanical reference design for Quad-Core Intel® Xeon® Processor 5400 Series. Both Quad-Core Intel® Xeon® Processor X5400 Series and Quad-Core Intel® Xeon® Processor E5400 Series are targeted for the full range of form factors (2U, 2U+ and 1U). The Quad-Core Intel® Xeon® Processor X5482 sku is an ultra performance version of the Quad-Core Intel® Xeon® Processor 5400 Series with 150W TDP and is use only in workstation platforms.

2.1 Mechanical Requirements

The mechanical performance of the processor cooling solution must satisfy the requirements described in this section.

2.1.1 Processor Mechanical Parameters

Table 2-1. Processor Mechanical Parameters Table

Parameter	Minimum	Maximum	Unit	Notes
Volumetric Requirements and Keepouts				1
Static Compressive Load				3
Static Board Deflection				3
Dynamic Compressive Load				3
Transient Bend				3
Shear Load		70 311	lbf N	2,4,5
Tensile Load		25 111	lbf N	2,4,6
Torsion Load		35 3.95	in*lbf N*m	2,4,7

Notes:

1. Refer to drawings in [Appendix B](#).
2. In the case of a discrepancy, the most recent *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet* and *LGA771 Socket Mechanical Design Guide* supersede targets listed in [Table 2-1](#) above.
3. These socket limits are defined in the *LGA771 Socket Mechanical Design Guide*.
4. These package handling limits are defined in the *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet*.
5. Shear load that can be applied to the package IHS.
6. Tensile load that can be applied to the package IHS.
7. Torque that can be applied to the package IHS.



2.1.2 Quad-Core Intel® Xeon® Processor 5400 Series Package

The Quad-Core Intel® Xeon® Processor 5400 Series is packaged using the flip-chip land grid array (FC-LGA) package technology. Please refer to the *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet* for detailed mechanical specifications. The Quad-Core Intel® Xeon® Processor 5400 Series mechanical drawing shown in [Figure 2-1](#), [Figure 2-2](#), and [Figure 2-3](#) provide the mechanical information for the Quad-Core Intel® Xeon® Processor 5400 Series. The drawing is superseded with the drawing in the processor datasheet should there be any conflicts. Integrated package/socket stackup height information is provided in the *LGA771 Socket Mechanical Design Guide*.

[illegible]

Quad-Core Intel® Xeon® Processor 5400 Series TMDG

Figure 2-2. Quad-Core Intel® Xeon® Processor 5400 Series Mechanical Drawing (2 of 3)

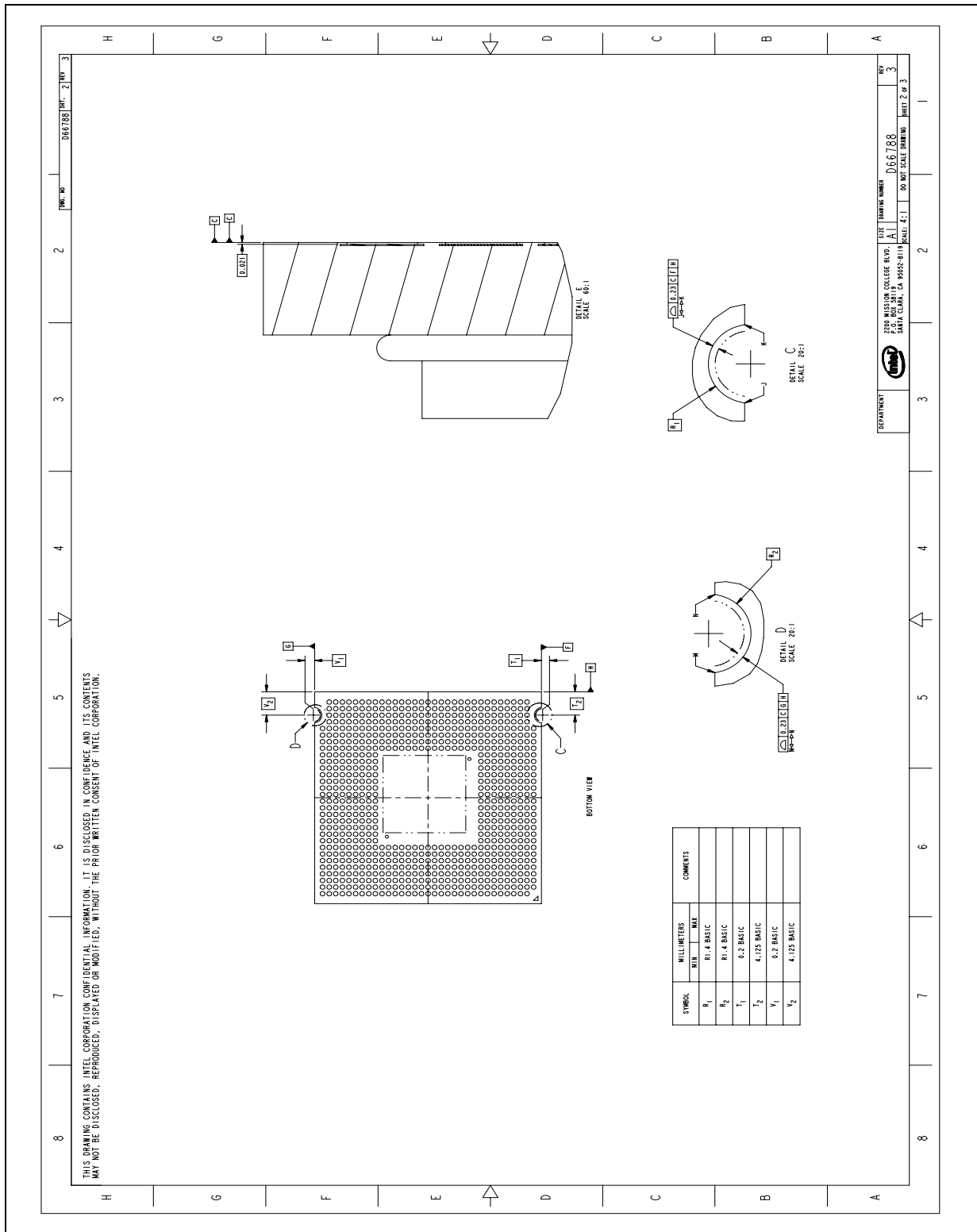
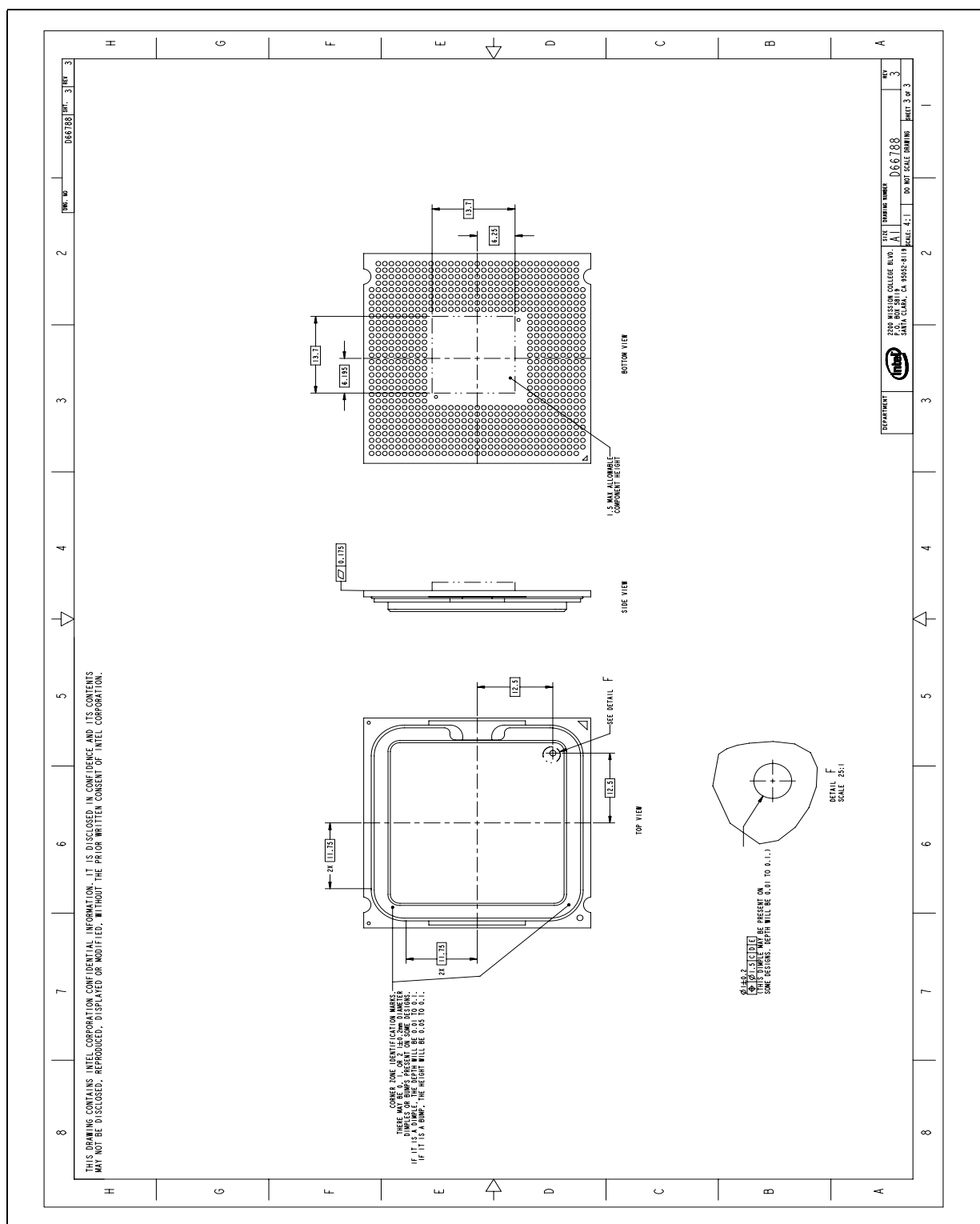


Figure 2-3. Quad-Core Intel® Xeon® Processor 5400 Series Mechanical Drawing (3 of 3)



Note: The optional dimple packing marking highlighted by Detail F from the above drawing may only be found on initial processors.



The package includes an integrated heat spreader (IHS). The IHS transfers the non-uniform heat from the die to the top of the IHS, out of which the heat flux is more uniform and spreads over a larger surface area (not the entire IHS area). This allows more efficient heat transfer out of the package to an attached cooling device. The IHS is designed to be the interface for contacting a heatsink. Details can be found in the *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet*.

The processor connects to the baseboard through a 771-land surface mount socket. A description of the socket can be found in the *LGA771 Socket Mechanical Design Guide*.

The processor package and socket have mechanical load limits that are specified in the *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet* and the *LGA771 Socket Mechanical Design Guide*. These load limits should not be exceeded during heatsink installation, removal, mechanical stress testing, or standard shipping conditions. For example, when a compressive static load is necessary to ensure thermal performance of the Thermal Interface Material (TIM) between the heatsink base and the IHS, it should not exceed the corresponding specification given in the *LGA771 Socket Mechanical Design Guide*.

The heatsink mass can also add additional dynamic compressive load to the package during a mechanical shock event. Amplification factors due to the impact force during shock must be taken into account in dynamic load calculations. The total combination of dynamic and static compressive load should not then exceed the processor/socket compressive dynamic load specified in the *LGA771 Socket Mechanical Design Guide* during a vertical shock. It is not recommended to use any portion of the processor substrate as a mechanical reference or load-bearing surface in either static or dynamic compressive load conditions.

2.1.3 Quad-Core Intel® Xeon® Processor 5400 Series Considerations

An attachment mechanism must be designed to support the heatsink since there are no features on the LGA771 socket to directly attach a heatsink. In addition to holding the heatsink in place on top of the IHS, this mechanism plays a significant role in the robustness of the system in which it is implemented, in particular:

- Ensuring thermal performance of the TIM applied between the IHS and the heatsink. TIMs, especially ones based on phase change materials, are very sensitive to applied pressure: the higher the pressure, the better the initial performance. TIMs such as thermal greases are not as sensitive to applied pressure. Refer to [Section 2.5.2](#) and [Section 2.5.7.2](#) for information on tradeoffs made with TIM selection. Designs should consider possible decrease in applied pressure over time due to potential structural relaxation in enabled components.
- Ensuring system electrical, thermal, and structural integrity under shock and vibration events. The mechanical requirements of the attach mechanism depend on the weight of the heatsink and the level of shock and vibration that the system must support. The overall structural design of the baseboard and system must be considered when designing the heatsink attach mechanism. Their design should provide a means for protecting LGA771 socket solder joints as well as preventing package pullout from the socket.

Note:

The load applied by the attachment mechanism must comply with the package and socket specifications, along with the dynamic load added by the mechanical shock and vibration requirements, as identified in [Section 2.1.1](#).



A potential mechanical solution for heavy heatsinks is the direct attachment of the heatsink to the chassis pan. In this case, the strength of the chassis pan can be utilized rather than solely relying on the baseboard strength. In addition to the general guidelines given above, contact with the baseboard surfaces should be minimized during installation in order to avoid any damage to the baseboard.

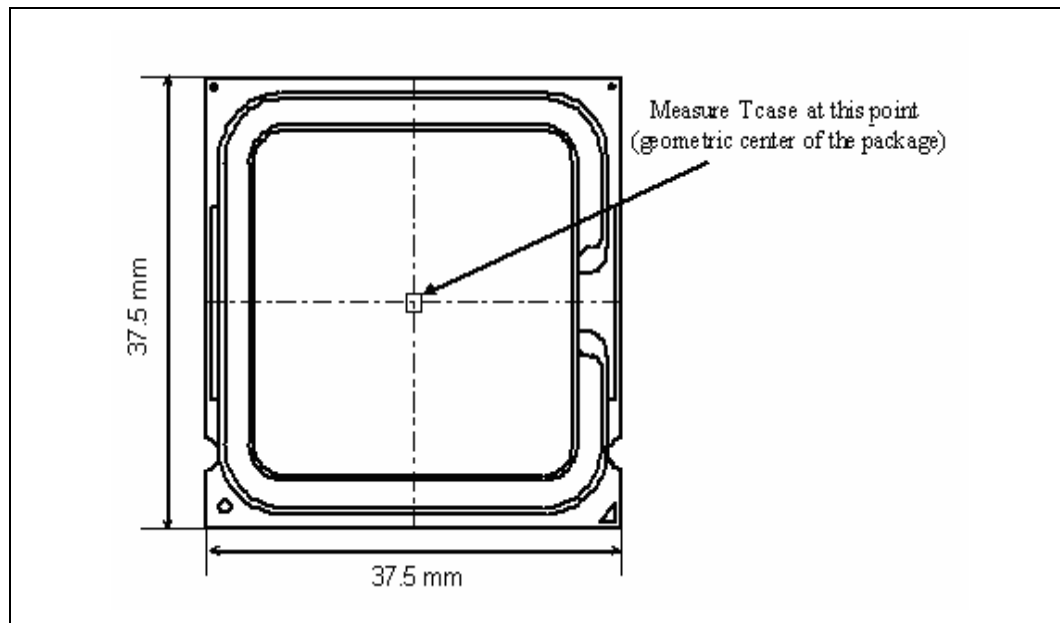
The Intel reference design for Quad-Core Intel® Xeon® Processor 5400 Series is using such a heatsink attachment scheme. Refer to [Section 2.5](#) for further information regarding the Intel reference mechanical solution.

2.2 Processor Thermal Parameters and Features

2.2.1 Thermal Control Circuit and TDP

The operating thermal limits of the processor are defined by the Thermal Profile. The intent of the Thermal Profile specification is to support acoustic noise reduction through fan speed control and ensure the long-term reliability of the processor. This specification requires that the temperature at the center of the processor IHS, known as (T_{CASE}) remains within a certain temperature specification. For illustration, [Figure 2-4](#) shows the measurement location for the Quad-Core Intel® Xeon® Processor 5400 Series package. Compliance with the T_{CASE} specification is required to achieve optimal operation and long-term reliability (See the *Intel® Xeon® Dual- and Multi- Processor Family Thermal Test Vehicle User's Guide* for Case Temperature definition and measurement methods).

Figure 2-4. Processor Case Temperature Measurement Location



To ease the burden on thermal solutions, the Thermal Monitor feature and associated logic have been integrated into the silicon of the processor. One feature of the Thermal Monitor is the Thermal Control Circuit (TCC). When active, the TCC lowers the processor temperature by reducing power consumption. This is accomplished through a combination of Thermal Monitor and Advanced Thermal Monitor (TM2). Thermal Monitor modulates the duty cycle of the internal processor clocks, resulting in a lower effective frequency. When active, the TCC turns the processor clocks off and then back on with a predetermined duty cycle. Thermal Monitor 2 activation adjusts both the



processor operating frequency (via the bus multiplier) and input voltage (via the VID signals). Please refer to the *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet* for further details on TM and TM2.

PROCHOT# is designed to assert at or a few degrees higher than maximum T_{CASE} (as specified by the thermal profile) when dissipating TDP power, and can not be interpreted as an indication of processor case temperature. This temperature delta accounts for processor package, lifetime, and manufacturing variations and attempts to ensure the Thermal Control Circuit is not activated below maximum T_{CASE} when dissipating TDP power. There is no defined or fixed correlation between the PROCHOT# assertion temperature and the case temperature. However, with the introduction of the Digital Thermal Sensor (DTS) on the *Quad-Core Intel® Xeon® Processor 5400 Series*, the DTS reports a relative offset below the PROCHOT# assertion (see [Section 2.2.2](#) for more details on the Digital Thermal Sensor). Thermal solutions must be designed to the processor specifications (i.e Thermal Profile) and can not be adjusted based on experimental measurements of T_{CASE} , PROCHOT#, or Digital Thermal Sensor on random processor samples.

By taking advantage of the Thermal Monitor features, system designers may reduce thermal solution cost by designing to the Thermal Design Power (TDP) instead of maximum power. TDP should be used for processor thermal solution design targets. TDP is not the maximum power that the processor can dissipate. TDP is based on measurements of processor power consumption while running various high power applications. This data set is used to determine those applications that are interesting from a power perspective. These applications are then evaluated in a controlled thermal environment to determine their sensitivity to activation of the thermal control circuit. This data set is then used to derive the TDP targets published in the processors datasheet. The Thermal Monitor can protect the processors in rare workload excursions above TDP. Therefore, thermal solutions should be designed to dissipate this target power level. The thermal management logic and thermal monitor features are discussed in extensive detail in the *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet*.

In addition, on-die thermal management features called THERMTRIP# and FORCEPR# are available on the Quad-Core Intel® Xeon® Processor 5400 Series. They provide a thermal management approach to support the continued increases in processor frequency and performance. Please see the *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet* for guidance on these thermal management features.

2.2.2 Digital Thermal Sensor

The Quad-Core Intel® Xeon® Processor 5400 Series include on-die temperature sensor feature called Digital Thermal Sensor (DTS). The DTS uses the same sensor utilized for TCC activation. Each individual processor is calibrated so that TCC activation occurs at a DTS value of 0. The temperature reported by the DTS is the relative offset in PECI counts below the onset of the TCC activation and hence is negative. Changes in PECI counts are roughly linear in relation to temperature changes in degrees Celsius. For example, a change in PECI count by '1' represents a change in temperature of approximately 1°C. However, this linearity cannot be guaranteed as the offset below TCC activation exceeds 20-30 PECI counts. Also note that the DTS will not report any values above the TCC activation temperature, it will simply return 0 in this case.

The DTS facilitates the use of multiple thermal sensors within the processor without the burden of increasing the number of thermal sensor signal pins on the processor package. Operation of multiple DTS will be discussed in more detail in [Section 2.2.4](#). Also, the DTS utilizes thermal sensors that are optimally located when compared with thermal diodes available with legacy processors. This is achieved as a result of a

smaller foot print and decreased sensitivity to noise. These DTS benefits will result in more accurate fan speed control and TCC activation. The DTS application in fan speed control will be discussed in more detail in [Section 2.4.1](#).

2.2.3 Platform Environmental Control Interface (PECI)

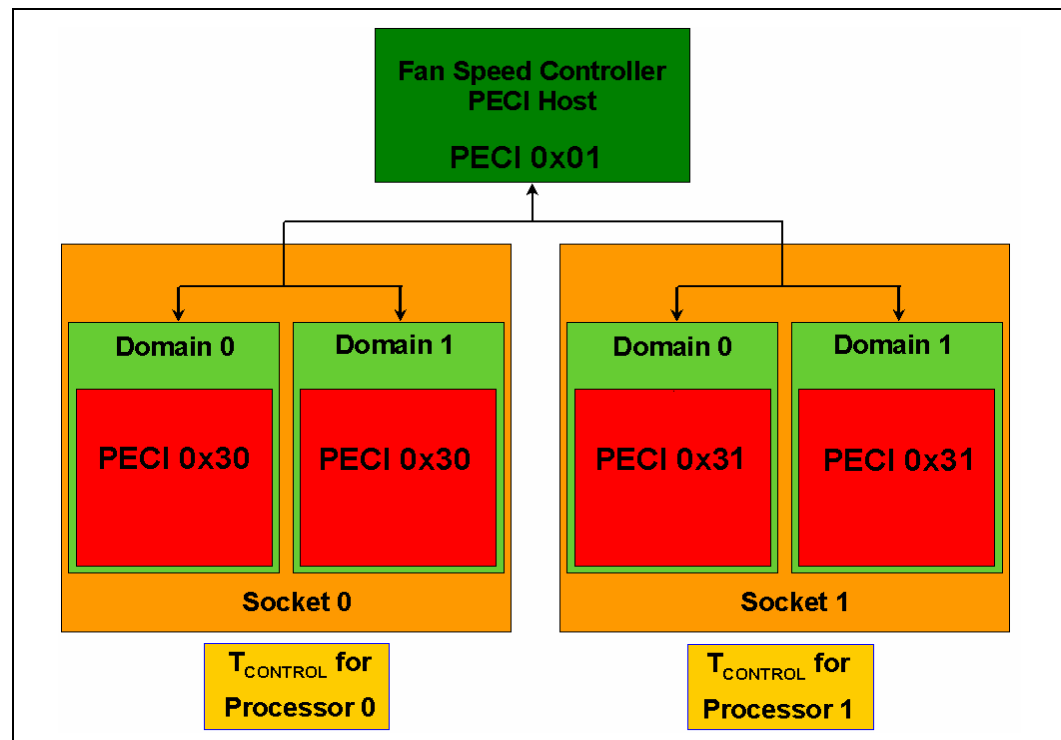
The PECI interface is designed specifically to convey system management information from the processor (initially, only thermal data from the Digital Thermal Sensor). It is a proprietary single wire bus between the processor and the chipset or other health monitoring device. The PECI specification provides a specific command set to discover, enumerate devices, and read the temperature. For an overview of the PECI interface, please refer to *PECI Feature Set Overview*. For more detailed information on PECI, please refer to *Platform Environment Control Interface (PECI) Specification* and *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet*.

2.2.4 Multiple Core Special Considerations

2.2.4.1 Multiple Digital Thermal Sensor Operation

Each Quad-Core Intel® Xeon® Processor 5400 Series can have multiple Digital Thermal Sensors located on the die. Each die within the processor currently maps to a PECI domain. The Quad-Core Intel® Xeon® Processor 5400 Series contains two cores per die (domain) and two domains (die) per socket. BIOS will be responsible for detecting the proper processor type and providing the number of domains to the thermal management system. An external PECI device that is part of the thermal management system polls the processor domains for temperature information and currently receives the highest of the DTS output temperatures within each domain. [Figure 2-5](#) provides an illustration of the DTS domains for the Quad-Core Intel® Xeon® Processor 5400 Series.

Figure 2-5. DTS Domain for Quad-Core Intel® Xeon® Processor 5400 Series





2.2.4.2 Thermal Monitor for Multiple Core Products

The thermal management for multiple core products has only one T_{CONTROL} value per processor. The T_{CONTROL} for processor 0 and T_{CONTROL} for processor 1 are independent from each other. If the DTS temperature from any domain within the processor is greater than or equal to T_{CONTROL} , the processor case temperature must remain at or below the temperature as specified by the thermal profile. See [Section 2.2.6](#) for information on T_{CONTROL} . The PECI signal is available through CPU pin (G5) on each LGA771 socket for the Quad-Core Intel® Xeon® Processor 5400 Series. Through this pin, the two domains provide the current hottest value received from all the temperature sensors, to an external PECI device such as a thermal management system.

2.2.4.3 PROCHOT#, THERMTRIP#, and FORCEPR#

The PROCHOT# and THERMTRIP# outputs will be shared by all cores on a processor. The first core to reach TCC activation will assert PROCHOT#. A single FORCEPR# input will be shared by every core. [Table 2-2](#) provides an overview of input and output conditions for the Quad-Core Intel® Xeon® Processor 5400 Series thermal management features.

Table 2-2. Input and Output Conditions for the Quad-Core Intel® Xeon® Processor 5400 Series Thermal Management Features

Item	Processor Input	Processor Output
TM1/TM2	$DTS_{\text{Core } X} \geq \text{TCC Activation Temperature}$	All Cores TCC Activation
PROCHOT#	$DTS_{\text{Core } X} \geq \text{TCC Activation Temperature}$	PROCHOT# Asserted
THERMTRIP#	$DTS_{\text{Core } X} \geq \text{THERMTRIP \# Assertion Temperature}$	THERMTRIP# Asserted, all cores shut down
FORCEPR#	FORCEPR# Asserted	All Cores TCC Activation

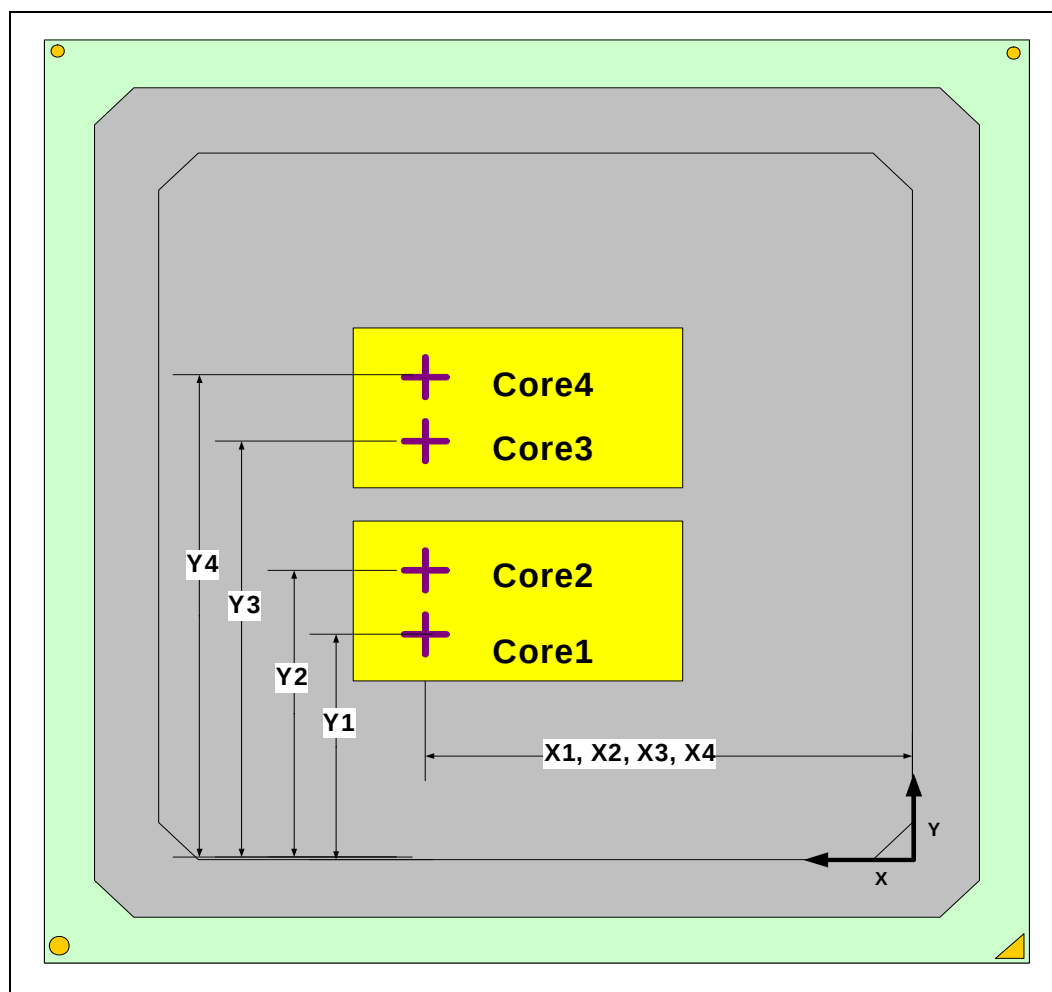
Note:

1. $X=1,2,3,4$; represents any one of the core1, core2, core3 and core4 in the Quad-Core Intel® Xeon® Processor 5400 Series.
2. For more information on PROCHOT#, THERMTRIP#, and FORCEPR# see the *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet*.

2.2.4.4 Heatpipe Orientation for Multiple Core Processors

Thermal management of multiple core processors can be achieved without the use of heatpipe heatsinks, as demonstrated by the Intel Reference Thermal Solution discussed in [Section 2.5](#).

To assist customers interested in designing heatpipe heatsinks, processor core locations have been provided. In some cases, this may influence the designer's selection of heatpipe orientation. For this purpose, the core geometric center locations, as illustrated in [Figure 2-6](#), are provided in [Table 2-3](#). Dimensions originate from the vertical edge of the IHS nearest to the pin 1 fiducial as shown in [Figure 2-6](#).

Figure 2-6. Processor Core Geometric Center Locations**Table 2-3. Processor Core Geometric Center Dimensions**

Feature	X Dimension	Y Dimension
Core 1	18.15 mm	6.15 mm
Core 2	18.15 mm	10.35 mm
Core 3	18.15 mm	18.85 mm
Core 4	18.15 mm	23.05 mm

2.2.5 Thermal Profile

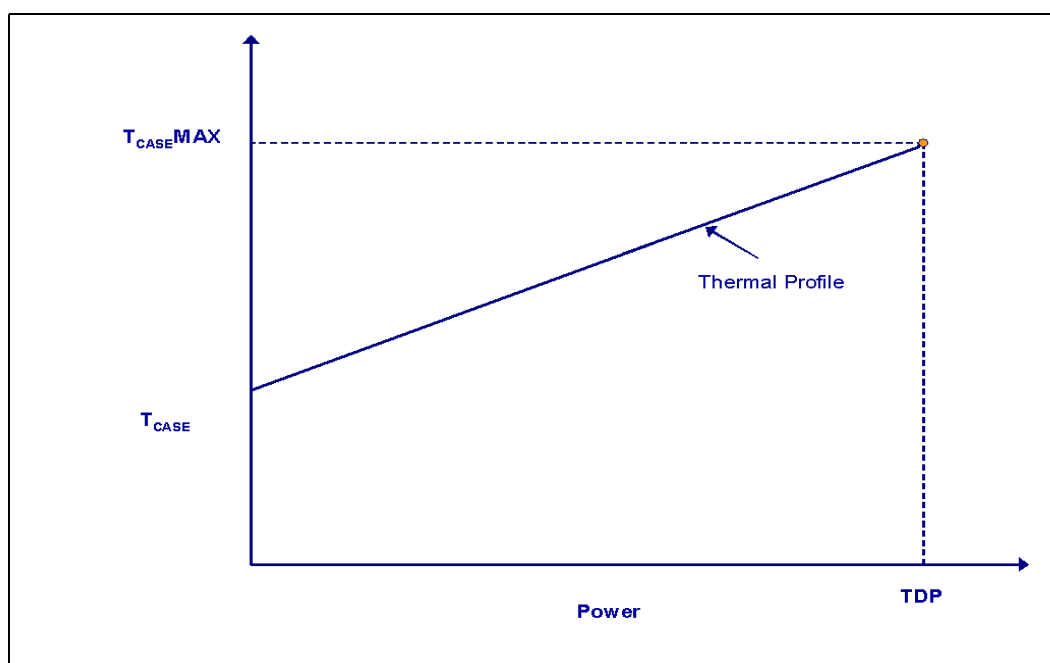
The thermal profile is a line that defines the relationship between a processor's case temperature and its power consumption as shown in Figure 2-7. The equation of the thermal profile is defined as:

Equation 2-1. $y = ax + b$

Where:

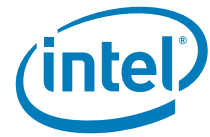
- y = Processor case temperature, T_{CASE} ($^{\circ}C$)
- x = Processor power consumption (W)
- a = Case-to-ambient thermal resistance, Ψ_{CA} ($^{\circ}C/W$)
- b = Processor local ambient temperature, TLA ($^{\circ}C$)

Figure 2-7. Thermal Profile Diagram



The high end point of the Thermal Profile represents the processor's TDP and the associated maximum case temperature (T_{CASE_MAX}) and the lower end point represents the local ambient temperature at $P = 0W$. The slope of the Thermal Profile line represents the case-to-ambient resistance of the thermal solution with the y-intercept being the local processor ambient temperature. The slope of the Thermal Profile is constant, which indicates that all frequencies of a processor defined by the Thermal Profile will require the same heatsink case-to-ambient resistance.

In order to satisfy the Thermal Profile specification, a thermal solution must be at or below the Thermal Profile line for the given processor when its DTS temperature is greater than $T_{CONTROL}$ (refer to Section 2.2.6). The Thermal Profile allows the customers to make a trade-off between the thermal solution case-to-ambient resistance and the processor local ambient temperature that best suits their platform implementation (refer to Section 2.4.3). There can be multiple combinations of thermal solution case-to-ambient resistance and processor local ambient temperature that can meet a given Thermal Profile. If the case-to-ambient resistance and the local ambient temperature are known for a specific thermal solution, the Thermal Profile of that solution can easily be plotted against the Thermal Profile specification. As explained

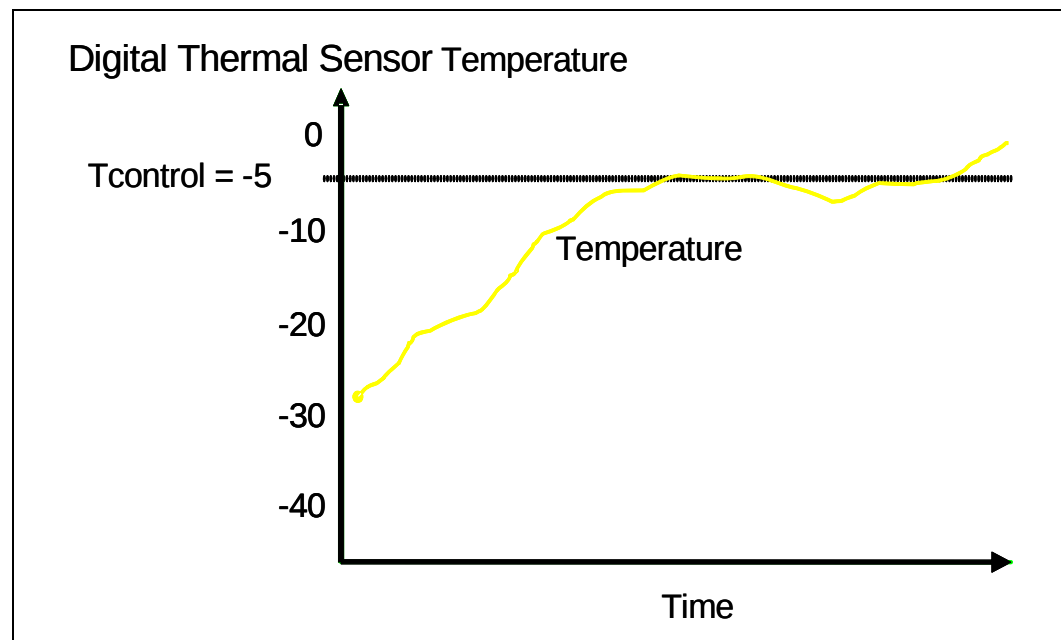


above, the case-to-ambient resistance represents the slope of the line and the processor local ambient temperature represents the y-axis intercept. Hence the T_{CASE_MAX} value of a specific solution can be calculated at TDP. Once this point is determined, the line can be extended to Power (P) = 0W representing the Thermal Profile of the specific solution. If that line stays at or below the Thermal Profile specification, then that particular solution is deemed as a compliant solution.

2.2.6 $T_{CONTROL}$ Definition

$T_{CONTROL}$ can be described as a trigger point for fan speed control implementation. The processor $T_{CONTROL}$ value provided by the Digital Thermal Sensor is relative and no longer absolute. The $T_{CONTROL}$ value is now defined as a relative value to the TCC activation set point (i.e. PECI Count = 0), as indicated by PROCHOT#. Figure 2-8 depicts the interaction between the $T_{CONTROL}$ value and Digital Thermal Sensor value.

Figure 2-8. $T_{CONTROL}$ Value and Digital Thermal Sensor Value Interaction



The value for $T_{CONTROL}$ is calibrated in manufacturing and configured for each processor individually. For the Quad-Core Intel® Xeon® Processor 5400 Series, the $T_{CONTROL}$ value is obtained by reading the processor model specific register (IA32_TEMPERATURE_TARGET MSR).

Note: There is no $T_{CONTROL_BASE}$ value to sum as previously required on legacy processors. The fan speed control device only needs to read the T_{OFFSET_MSR} and compare this to the DTS value from the PECI interface. The equation for calculating $T_{CONTROL}$ is:

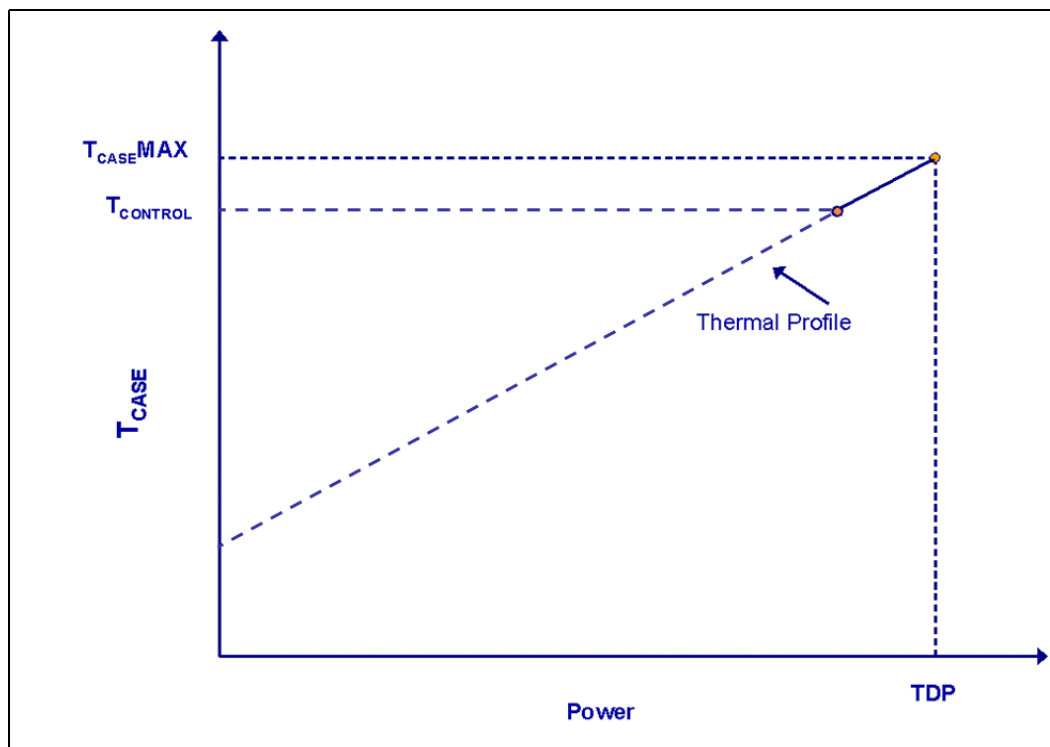
Equation 2-2. $T_{CONTROL} = -T_{OFFSET}$

Where:

T_{OFFSET} = A DTS-based value programmed into each processor during manufacturing that can be obtained by reading the IA32_TEMPERATURE_TARGET MSR. This is a static and a unique value. Refer to the *RS - Wolfedale Processor Family BIOS Writer's Guide (BWG)* for further details.

Figure 2-9 depicts the interaction between the Thermal Profile and T_{CONTROL} .

Figure 2-9. T_{CONTROL} and Thermal Profile Interaction



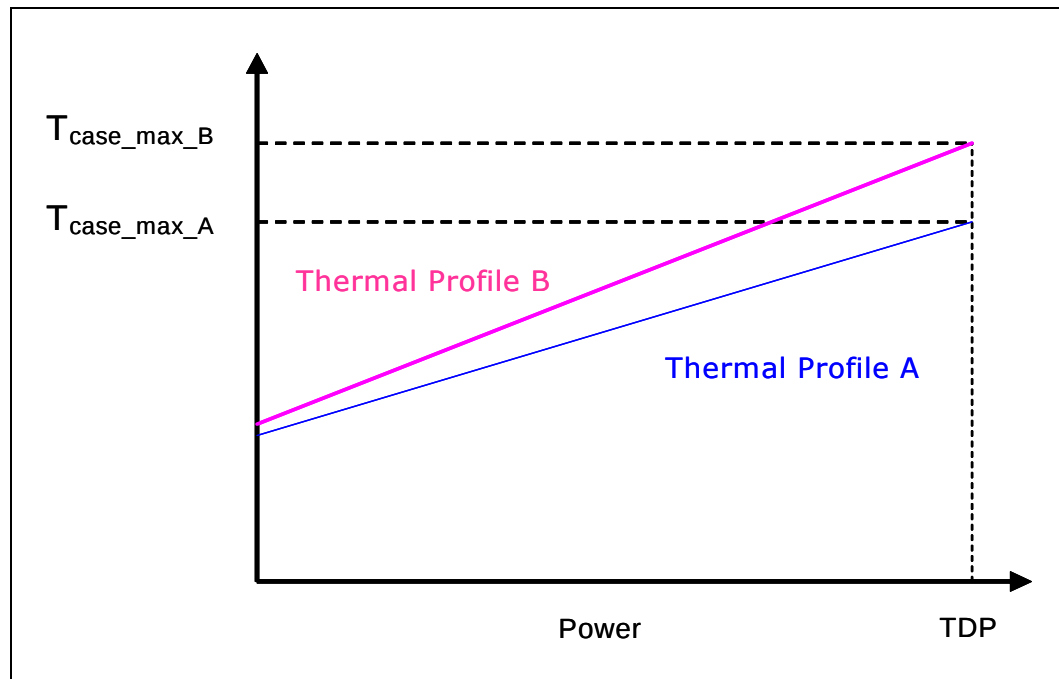
If the DTS temperature is less than T_{CONTROL} , then the case temperature is permitted to exceed the Thermal Profile, but the DTS temperature must remain at or below T_{CONTROL} . The thermal solution for the processor must be able to keep the processor's T_{CASE} at or below the Thermal Profile when operating between the T_{CONTROL} and $T_{\text{CASE_MAX}}$ at TDP under heavy workload conditions.

Refer to [Section 2.4.1](#) for the implementation of the T_{CONTROL} value in support of fan speed control (FSC) design to achieve better acoustic performance.

2.2.7 Thermal Profile Concepts for the Quad-Core Intel® Xeon® Processor 5400 Series

2.2.7.1 Dual Thermal Profile Concept for the Quad-Core Intel® Xeon® Processor X5400 Series

The Quad-Core Intel® Xeon® Processor X5400 Series is designed to go into various form factors, including the volumetrically constrained 1U and custom blade form factors. Due to certain limitations of such form factors (i.e. airflow, thermal solution height), it is very challenging to meet the thermal requirements of the processor. To mitigate these form factor constraints, Intel has developed a dual Thermal Profile specification, shown in [Figure 2-10](#).

Figure 2-10. Dual Thermal Profile Diagram

The Thermal Profile A is based on Intel's 2U+ air cooling solution. Designing to Thermal Profile A ensures that no measurable performance loss due to Thermal Control Circuit (TCC) activation is observed in the processor. It is expected that TCC would only be activated for very brief periods of time when running a worst-case real world application in a worst-case thermal condition. These brief instances of TCC activation are not expected to impact the performance of the processor. A worst case real world application is defined as a commercially available, useful application which dissipates a power equal to, or above, the TDP for a thermally relevant timeframe. One example of a worst-case thermal condition is when a processor local ambient temperature is at or above 42.8°C for Quad-Core Intel® Xeon® Processor X5400 Series Thermal Profile A.

Thermal Profile B supports volumetrically constrained platforms (i.e. 1U, blades, etc.), and is based on Intel's 1U air cooling solution. Because of the reduced capability represented by such thermal solutions, designing to Thermal Profile B results in an increased probability of TCC activation and an associated measurable performance loss. Measurable performance loss is defined to be any degradation in the processor's performance greater than 1.5%. The 1.5% number is chosen as the baseline since the run-to-run variation in a given performance benchmark is typically between 1 and 2%.

Although designing to Thermal Profile B results in increased T_{CASE} temperatures compared to Thermal Profile A at a given power level, both of these Thermal Profiles ensure that Intel's long-term processor reliability requirements are satisfied. In other words, designing to Thermal Profile B does not impose any additional risk to Intel's long-term reliability requirements. Thermal solutions that exceed Thermal Profile B specification are considered noncompliant and will adversely affect the long-term reliability of the processor.



Refer to the *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet* or [Section 2.2.8](#) for the Thermal Profile A and Thermal Profile B specifications. [Section 2.5](#) of this document also provides details on the 2U+ and 1U Intel reference thermal solutions that are designed to meet the Quad-Core Intel® Xeon® Processor X5400 Series Thermal Profile A and Thermal Profile B respectively.

2.2.7.2 Thermal Profile Concept for the Quad-Core Intel® Xeon® Processor E5400/X5482 Series

The Quad-Core Intel® Xeon® Processor E5400 Series is designed to go into various form factors, including the volumetrically constrained 1U and custom blade form factors. The Quad-Core Intel® Xeon® Processor X5482 is designed to go into volumetrically unconstrained workstation platforms only. Intel has developed single thermal profile for E5400/X5482 Series.

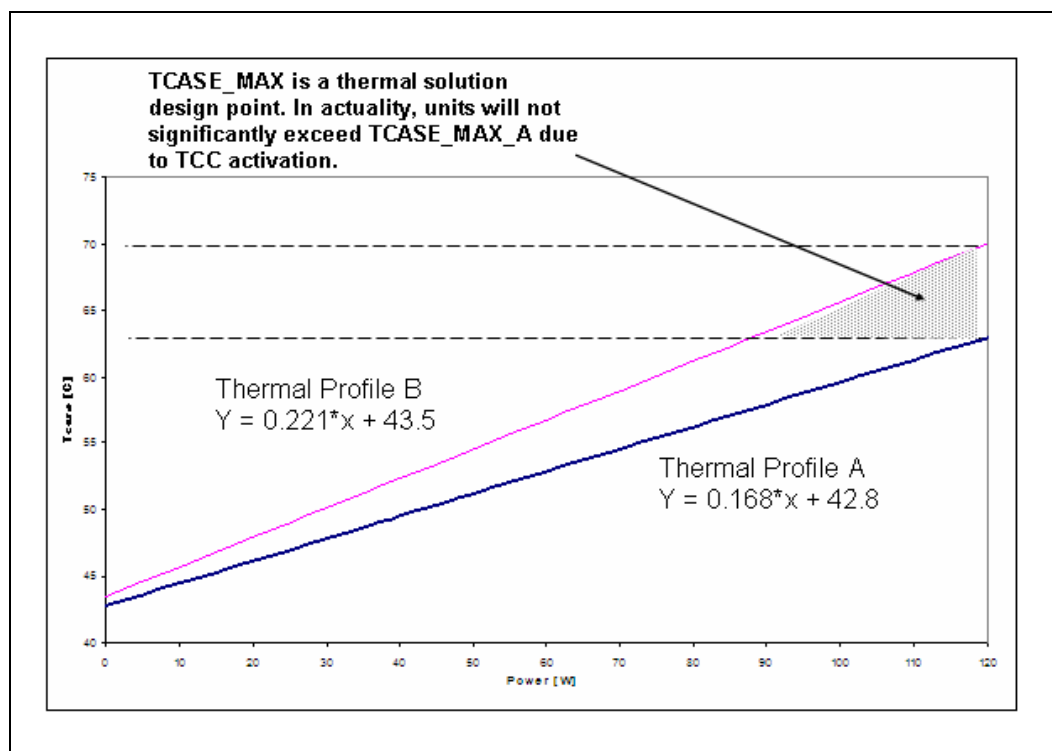
Designing to the Thermal Profile ensures that no measurable performance loss due to Thermal Control Circuit (TCC) activation is observed in the processor. It is expected that TCC would only be activated for very brief periods of time when running a worst-case real world application in a worst-case thermal condition. These brief instances of TCC activation are not expected to impact the performance of the processor. A worst case real world application is defined as a commercially available, useful application which dissipates a power equal to, or above, the TDP for a thermally relevant timeframe. One example of a worst-case thermal condition is when a processor local ambient temperature is at or above 43.2°C for Quad-Core Intel® Xeon® Processor E5400 Series Thermal Profile.

Thermal solutions that exceed the Thermal Profile specification are considered noncompliant and will adversely affect the long-term reliability of the processor.

Refer to the *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet* or [Section 2.2.8](#) for the Quad-Core Intel® Xeon® Processor 5400 Series Thermal Profile specifications. [Section 2.5](#) and [Appendix A](#) of this document provide details on 1U Intel reference thermal solutions that are designed to meet the Quad-Core Intel® Xeon® Processor E5400 Series Thermal Profile.

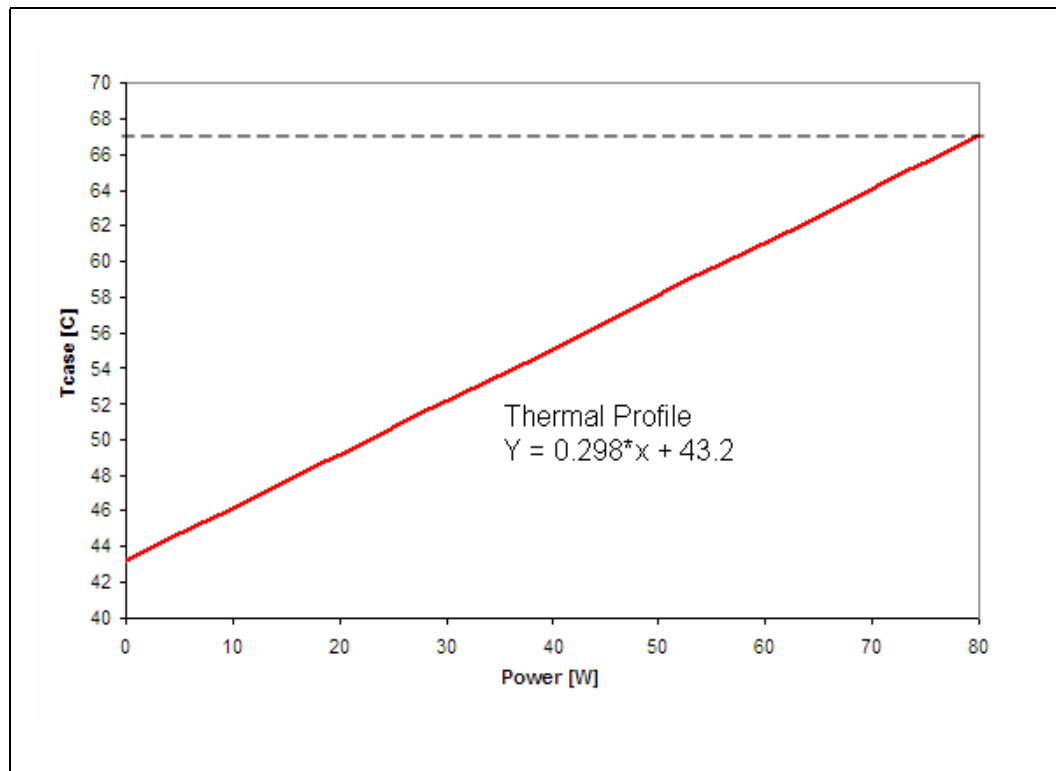
2.2.8 Performance Targets

The Thermal Profile specifications for this processor are published in the *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet*. These Thermal Profile specifications are shown as a reference in the subsequent discussions.


Figure 2-11. Thermal Profile for the Quad-Core Intel® Xeon® Processor X5400 Series

Notes:

1. The thermal specifications shown in this graph are for Quad-Core Intel® Xeon® Processor X5400 Series except the Quad-Core Intel® Xeon® Processor X5482 sku.
2. Refer to the Quad-Core Intel® Xeon® Processor 5400 Series Datasheet for the Thermal Profile specifications. In case of conflict, the data information in the datasheet supersedes any data in this figure.

Figure 2-12. Thermal Profile for Quad-Core Intel® Xeon® Processor E5400 Series



Note: The thermal specifications shown in this graph are for reference only. Refer to the *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet* for the Thermal Profile specifications. In case of conflict, the data information in the datasheet supersedes any data in this figure.

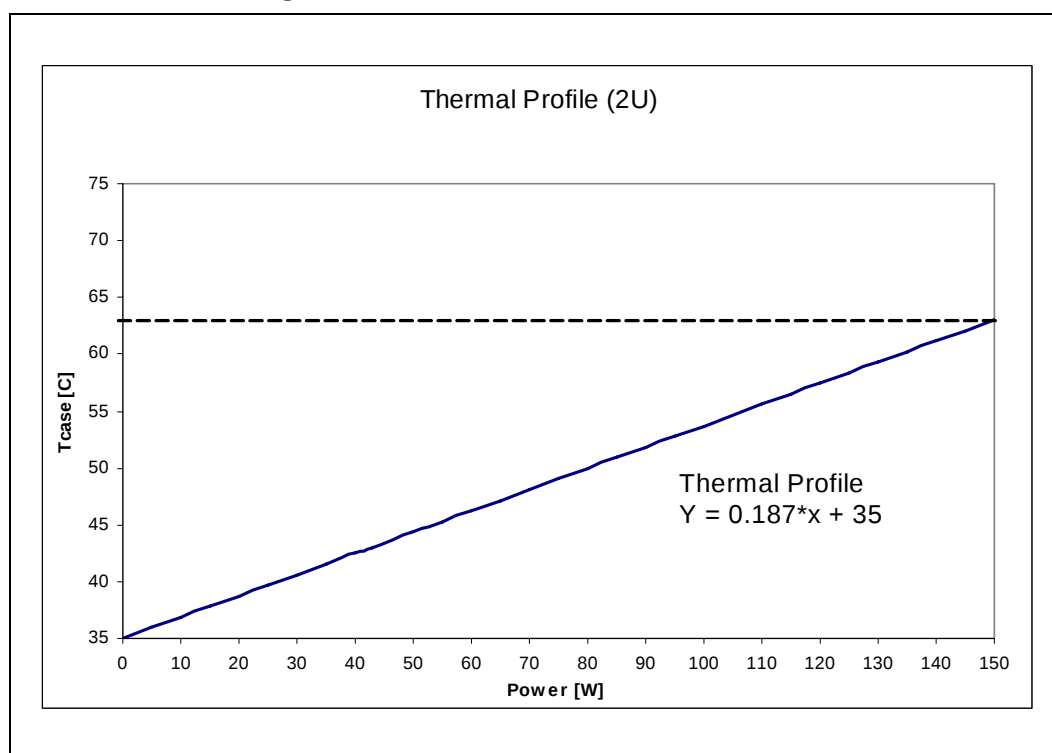
Figure 2-13. Thermal Profile for Quad-Core Intel® Xeon® Processor X5482 Series

Table 2-4 and Table 2-5 describe the thermal performance target for the Quad-Core Intel® Xeon® Processor 5400 Series cooling solution enabled by Intel.

Table 2-4. Intel Reference Heatsink Performance Targets for the Quad-Core Intel® Xeon® Processor X5400 Series

Parameter	Maximum	Unit	Notes
Altitude	Sea-level	m	Heatsink designed at 0 meters
T _{LA}	40	°C	
TDP	120	W	
2U+ CEK, Thermal Profile A			
T _{CASE_MAX_A}	63	°C	
Airflow	27 45.9	CFM m ³ / hr	Airflow through the heatsink fins
Pressure Drop	0.182 45.3	Inches of H ₂ O Pa	
Ψ _{CA}	0.187	°C/W	Mean + 3σ
1U CEK, Thermal Profile B			
T _{CASE_MAX_B}	70	°C	
Airflow	15 25.5	CFM m ³ / hr	Airflow through the heatsink fins
Pressure Drop	0.331 82.4	Inches of H ₂ O Pa	
Ψ _{CA}	0.246	°C/W	Mean + 3σ

**Table 2-5. Intel Reference Heatsink Performance Targets for the Quad-Core Intel® Xeon® Processor E5400 Series**

Parameter	Maximum	Unit	Notes
Altitude	Sea-Level	m	Heatsink designed at 0 meters
T _{LA}	40	°C	
TDP	80	W	
1U CEK			
T _{CASE_MAX}	67	°C	
Airflow	15 25.5	CFM m ³ / hr	Airflow through the heatsink fins
Pressure Drop	0.331 82.4	Inches of H ₂ O Pa	
Ψ _{CA}	0.246	°C/W	Mean + 3σ
1U Alternative Heatsink			
T _{CASE_MAX}	67	°C	
Airflow	15 25.5	CFM m ³ / hr	Airflow through the heatsink fins
Pressure Drop	0.331 82.4	Inches of H ₂ O Pa	
Ψ _{CA}	0.331	°C/W	Mean + 3σ

Note: Intel does not enable reference heatsink for the Quad-Core Intel® Xeon® Processor X5482 with 150W TDP. The Intel 2U CEK is capable of meeting the thermal specification when local ambient temperature (T_{LA}) is maintained at or below 35°C.

2.3 Fan Fail Guidelines

Under fan failure or other anomalous thermal excursions, Tcase may exceed Thermal Profile [Thermal Profile B for Quad-Core Intel® Xeon® Processor X5400 Series] for a duration totaling less than 360 hours per year without affecting long term reliability (life) of the processor. For more typical thermal excursions, Thermal Monitor is expected to control the processor power level as long as conditions do not allow the Tcase to exceed the temperature at which Thermal Control Circuit (TCC) activation initially occurred. Under more severe anomalous thermal excursions when the processor temperature cannot be controlled at or below this Tcase level by TCC activation, then data integrity is not assured. At some higher threshold THERMTRIP# will enable a shut down in an attempt to prevent permanent damage to the processor. Thermal Test Vehicles (TTVs) may be used to check anomalous thermal excursion compliance by ensuring that the processor Tcase value, as measured on the TTV, does not exceed Tcase_max [Tcase_max_B for Quad-Core Intel® Xeon® Processor X5400 Series] at the anomalous power level for the environmental condition of interest. This anomalous power level is equal to 80% of the TDP limit for Quad-Core Intel® Xeon® Processor X5400 Series with 120W TDP and 90% of the TDP limit for Quad-Core Intel® Xeon® Processor E5400 Series with 80W TDP.

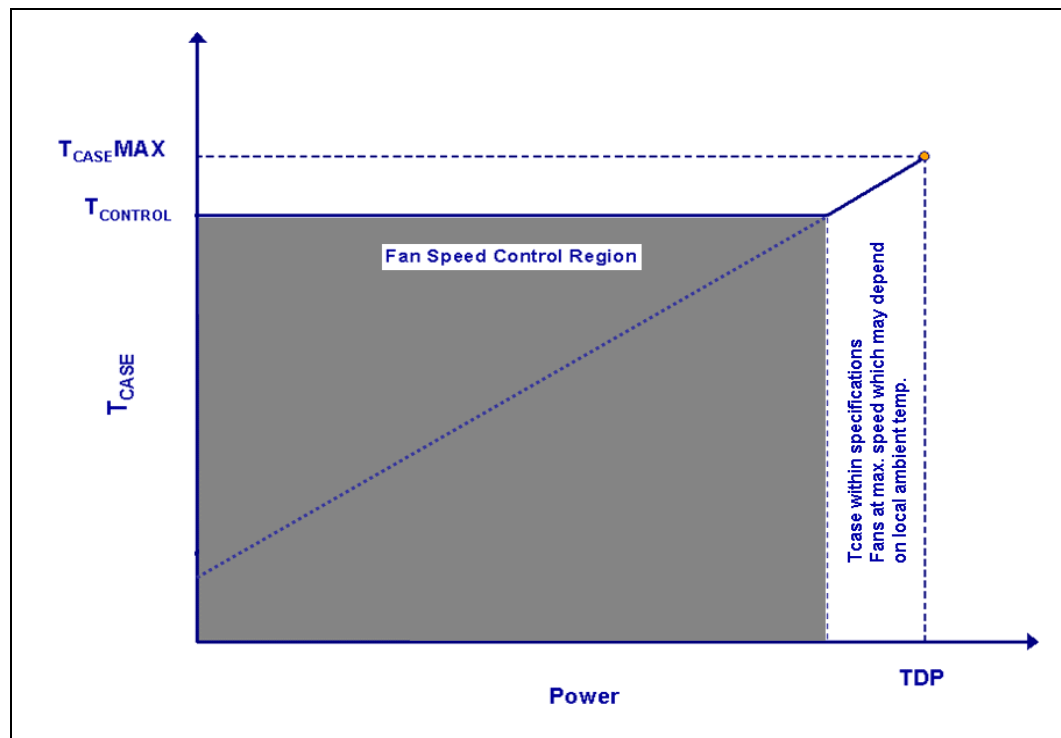
Note: Fan Failure Guidelines apply only to SKUs which have Thermal Monitor2 enabled.

2.4 Characterizing Cooling Solution Performance Requirements

2.4.1 Fan Speed Control

Fan speed control (FSC) techniques to reduce system level acoustic noise are a common practice in server designs. The fan speed is one of the parameters that determine the amount of airflow provided to the thermal solution. Additionally, airflow is proportional to a thermal solution's performance, which consequently determines the T_{CASE} of the processor at a given power level. Since the T_{CASE} of a processor is an important parameter in the long-term reliability of a processor, the FSC implemented in a system directly correlates to the processor's ability to meet the Thermal Profile and hence the long-term reliability requirements. For this purpose, the parameter called $T_{CONTROL}$ as explained in [Section 2.2.6](#), is to be used in FSC designs to ensure that the long-term reliability of the processor is met while keeping the system level acoustic noise down. [Figure 2-14](#) depicts the relationship between $T_{CONTROL}$ and FSC methodology.

Figure 2-14. $T_{CONTROL}$ and Fan Speed Control



Once the $T_{CONTROL}$ value is determined as explained earlier, the DTS temperature reading from the processor can be compared to this $T_{CONTROL}$ value. A fan speed control scheme can be implemented as described in [Table 2-6](#) without compromising the long-term reliability of the processor.

Table 2-6. Fan Speed Control, T_{CONTROL} and DTS Relationship

Condition	FSC Scheme
$DTS \leq T_{\text{CONTROL}}$	FSC can adjust fan speed to maintain $DTS \leq T_{\text{CONTROL}}$ (low acoustic region).
$DTS > T_{\text{CONTROL}}$	FSC should adjust fan speed to keep T_{CASE} at or below the Thermal Profile specification (increased acoustic region).

There are many different ways of implementing fan speed control, including FSC based on processor ambient temperature, FSC based on processor Digital Thermal Sensor (DTS) temperature or a combination of the two. If FSC is based only on the processor ambient temperature, low acoustic targets can be achieved under low ambient temperature conditions. However, the acoustics cannot be optimized based on the behavior of the processor temperature. If FSC is based only on the Digital Thermal Sensor, sustained temperatures above T_{CONTROL} drives fans to maximum RPM. If FSC is based both on ambient and Digital Thermal Sensor, ambient temperature can be used to scale the fan RPM controlled by the Digital Thermal Sensor. This would result in an optimal acoustic performance. Regardless of which scheme is employed, system designers must ensure that the Thermal Profile specification is met when the processor Digital Thermal Sensor temperature exceeds the T_{CONTROL} value for a given processor.

2.4.2 Processor Thermal Characterization Parameter Relationships

The idea of a “thermal characterization parameter”, Ψ (psi), is a convenient way to characterize the performance needed for the thermal solution and to compare thermal solutions in identical conditions (heating source, local ambient conditions). A thermal characterization parameter is convenient in that it is calculated using total package power, whereas actual thermal resistance, θ (theta), is calculated using actual power dissipated between two points. Measuring actual power dissipated into the heatsink is difficult, since some of the power is dissipated via heat transfer into the socket and board. Be aware, however, of the limitations of lumped parameters such as Ψ when it comes to a real design. Heat transfer is a three-dimensional phenomenon that can rarely be accurately and easily modeled by lump values.

The case-to-local ambient thermal characterization parameter value (Ψ_{CA}) is used as a measure of the thermal performance of the overall thermal solution that is attached to the processor package. It is defined by the following equation, and measured in units of $^{\circ}\text{C}/\text{W}$:

Equation 2-3. $\Psi_{\text{CA}} = (T_{\text{CASE}} - T_{\text{LA}}) / \text{TDP}$

Where:

- Ψ_{CA} = Case-to-local ambient thermal characterization parameter ($^{\circ}\text{C}/\text{W}$).
- T_{CASE} = Processor case temperature ($^{\circ}\text{C}$).
- T_{LA} = Local ambient temperature in chassis at processor ($^{\circ}\text{C}$).
- TDP** = TDP dissipation (W) (assumes all power dissipates through the integrated heat spreader (IHS)).

The case-to-local ambient thermal characterization parameter of the processor, Ψ_{CA} , is comprised of Ψ_{CS} , the TIM thermal characterization parameter, and of Ψ_{SA} , the sink-to-local ambient thermal characterization parameter:

Equation 2-4. $\Psi_{CA} = \Psi_{CS} + \Psi_{SA}$

Where:

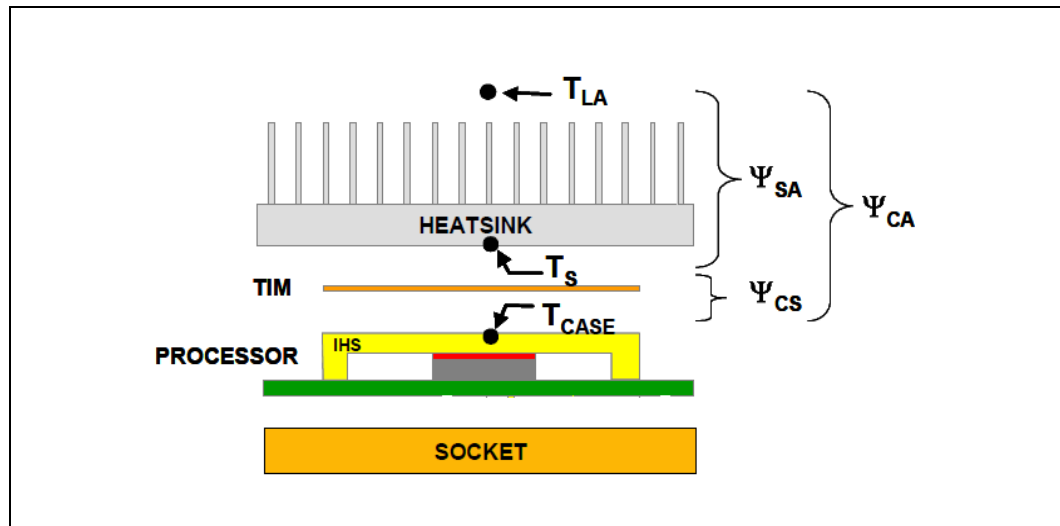
- Ψ_{CS} = Thermal characterization parameter of the TIM ($^{\circ}\text{C}/\text{W}$).
- Ψ_{SA} = Thermal characterization parameter from heatsink-to-local ambient ($^{\circ}\text{C}/\text{W}$).

Ψ_{CS} is strongly dependent on the thermal conductivity and thickness of the TIM between the heatsink and IHS.

Ψ_{SA} is a measure of the thermal characterization parameter from the bottom of the heatsink to the local ambient air. Ψ_{SA} is dependent on the heatsink material, thermal conductivity, and geometry. It is also strongly dependent on the air velocity through the fins of the heatsink.

Figure 2-15 illustrates the combination of the different thermal characterization parameters.

Figure 2-15. Processor Thermal Characterization Parameter Relationships



2.4.2.1 Example

The cooling performance, Ψ_{CA} , is then defined using the principle of thermal characterization parameter described above:

- Define a target case temperature T_{CASE_MAX} and corresponding TDP, given in the processor datasheet.
- Define a target local ambient temperature at the processor, T_{LA} .

The following provides an illustration of how one might determine the appropriate performance targets. The example power and temperature numbers used here are not related to any Intel processor thermal specifications, and are for illustrative purposes only.



Assume the datasheet TDP is 85 W and the case temperature specification is 68 °C. Assume as well that the system airflow has been designed such that the local processor ambient temperature is 45°C. Then the following could be calculated using equation (2-3) from above:

Equation 2-5. $\Psi_{CA} = (T_{CASE} - T_{LA}) / TDP = (68 - 45) / 85 = 0.27 \text{ }^{\circ}\text{C/W}$

To determine the required heatsink performance, a heatsink solution provider would need to determine Ψ_{CS} performance for the selected TIM and mechanical load configuration. If the heatsink solution was designed to work with a TIM material performing at $\Psi_{CS} \leq 0.05 \text{ }^{\circ}\text{C/W}$, solving for equation (2-4) from above, the performance of the heatsink would be:

Equation 2-6. $\Psi_{SA} = \Psi_{CA} - \Psi_{CS} = 0.27 - 0.05 = 0.22 \text{ }^{\circ}\text{C/W}$

If the local processor ambient temperature is assumed to be 40°C, the same calculation can be carried out to determine the new case-to-ambient thermal resistance:

Equation 2-7. $\Psi_{CA} = (T_{CASE} - T_{LA}) / TDP = (68 - 40) / 85 = 0.33 \text{ }^{\circ}\text{C/W}$

It is evident from the above calculations that, a reduction in the local processor ambient temperature has a significant positive effect on the case-to-ambient thermal resistance requirement.

2.4.3 Chassis Thermal Design Considerations

2.4.3.1 Chassis Thermal Design Capabilities and Improvements

One of the critical parameters in thermal design is the local ambient temperature assumption of the processor. Keeping the external chassis temperature fixed, internal chassis temperature rise is the only component that can affect the processor local ambient temperature. Every degree gained at the local ambient temperature directly translates into a degree relief in the processor case temperature.

Given the thermal targets for the processor, it is extremely important to optimize the chassis design to minimize the air temperature rise upstream to the processor (T_{rise}), hence minimizing the processor local ambient temperature.

The heat generated by components within the chassis must be removed to provide an adequate operating environment for both the processor and other system components. Moving air through the chassis brings in air from the external ambient environment and transports the heat generated by the processor and other system components out of the system. The number, size and relative position of fans, vents and other heat generating components determine the chassis thermal performance, and the resulting ambient temperature around the processor. The size and type (passive or active) of the thermal solution and the amount of system airflow can be traded off against each other to meet specific system design constraints. Additional constraints are board layout, spacing, component placement, and structural considerations that limit the thermal solution size.

In addition to passive heatsinks, fan heatsinks and system fans, other solutions exist for cooling integrated circuit devices. For example, ducted blowers, heat pipes and liquid cooling are all capable of dissipating additional heat. Due to their varying attributes, each of these solutions may be appropriate for a particular system implementation.



To develop a reliable, cost-effective thermal solution, thermal characterization and simulation should be carried out at the entire system level, accounting for the thermal requirements of each component. In addition, acoustic noise constraints may limit the size, number, placement, and types of fans that can be used in a particular design.

2.5 Thermal/Mechanical Reference Design Considerations

2.5.1 Heatsink Solutions

2.5.1.1 Heatsink Design Considerations

To remove the heat from the processor, three basic parameters should be considered:

- **The area of the surface on which the heat transfer takes place** - Without any enhancements, this is the surface of the processor package IHS. One method used to improve thermal performance is by attaching a heatsink to the IHS. A heatsink can increase the effective heat transfer surface area by conducting heat out of the IHS and into the surrounding air through fins attached to the heatsink base.
- **The conduction path from the heat source to the heatsink fins** - Providing a direct conduction path from the heat source to the heatsink fins and selecting materials with higher thermal conductivity typically improves heatsink performance. The length, thickness, and conductivity of the conduction path from the heat source to the fins directly impact the thermal performance of the heatsink. In particular, the quality of the contact between the package IHS and the heatsink base has a higher impact on the overall thermal solution performance as processor cooling requirements become strict. Thermal interface material (TIM) is used to fill in the gap between the IHS and the bottom surface of the heatsink, and thereby improves the overall performance of the thermal stackup (IHS-TIM-Heatsink). With extremely poor heatsink interface flatness or roughness, TIM may not adequately fill the gap. The TIM thermal performance depends on its thermal conductivity as well as the pressure load applied to it. Refer to [Section 2.5.2](#) for further information on the TIM between the IHS and the heatsink base.
- **The heat transfer conditions on the surface on which heat transfer takes place** - Convective heat transfer occurs between the airflow and the surface exposed to the flow. It is characterized by the local ambient temperature of the air, T_{LA} , and the local air velocity over the surface. The higher the air velocity over the surface, the resulting cooling is more efficient. The nature of the airflow can also enhance heat transfer via convection. Turbulent flow can provide improvement over laminar flow. In the case of a heatsink, the surface exposed to the flow includes the fin faces and the heatsink base.

An active heatsink typically incorporates a fan that helps manage the airflow through the heatsink.

Passive heatsink solutions require in-depth knowledge of the airflow in the chassis. Typically, passive heatsinks see slower air speed. Therefore, these heatsinks are typically larger (and heavier) than active heatsinks due to the increase in fin surface required to meet a required performance. As the heatsink fin density (the number of fins in a given cross-section) increases, the resistance to the airflow increases: it is more likely that the air will travel around the heatsink instead of through it, unless air bypass is carefully managed. Using air-ducting techniques to manage bypass area is an effective method for maximizing airflow through the heatsink fins.

2.5.2 Thermal Interface Material

TIM application between the processor IHS and the heatsink base is generally required to improve thermal conduction from the IHS to the heatsink. Many thermal interface materials can be pre-applied to the heatsink base prior to shipment from the heatsink supplier and allow direct heatsink attach, without the need for a separate TIM dispense or attach process in the final assembly factory.

All thermal interface materials should be sized and positioned on the heatsink base in a way that ensures the entire processor IHS area is covered. It is important to compensate for heatsink-to-processor attach positional alignment when selecting the proper TIM size.

When pre-applied material is used, it is recommended to have a protective application tape over it. This tape must be removed prior to heatsink installation.

The TIM performance is susceptible to degradation (i.e. grease breakdown) during the useful life of the processor due to the temperature cycling phenomena. For this reason, the measured T_{CASE} value of a given processor can decrease over time depending on the type of TIM material.

Refer to [Section 2.5.7.2](#) for information on the TIM used in the Intel reference heatsink solution.

2.5.3 Summary

In summary, considerations in heatsink design include:

- The local ambient temperature T_{LA} at the heatsink, airflow (CFM), the power being dissipated by the processor, and the corresponding maximum T_{CASE} temperature. These parameters are usually combined in a single lump cooling performance parameter, Ψ_{CA} (case to air thermal characterization parameter). More information on the definition and the use of Ψ_{CA} is given in [Section 2.5](#) and [Section 2.4.2](#).
- Heatsink interface (to IHS) surface characteristics, including flatness and roughness.
- The performance of the TIM used between the heatsink and the IHS.
- Surface area of the heatsink.
- Heatsink material and technology.
- Development of airflow entering and within the heatsink area.
- Physical volumetric constraints placed by the system.
- Integrated package/socket stackup height information is provided in the *LGA771 Socket Mechanical Design Guide*.

2.5.4 Assembly Overview of the Intel Reference Thermal Mechanical Design

The reference design heatsinks that meet the Quad-Core Intel® Xeon® Processor 5400 Series thermal performance targets are called the Common Enabling Kit (CEK) heatsinks, and are available in 1U, 2U, & 2U+ form factors. Each CEK consists of the following components:

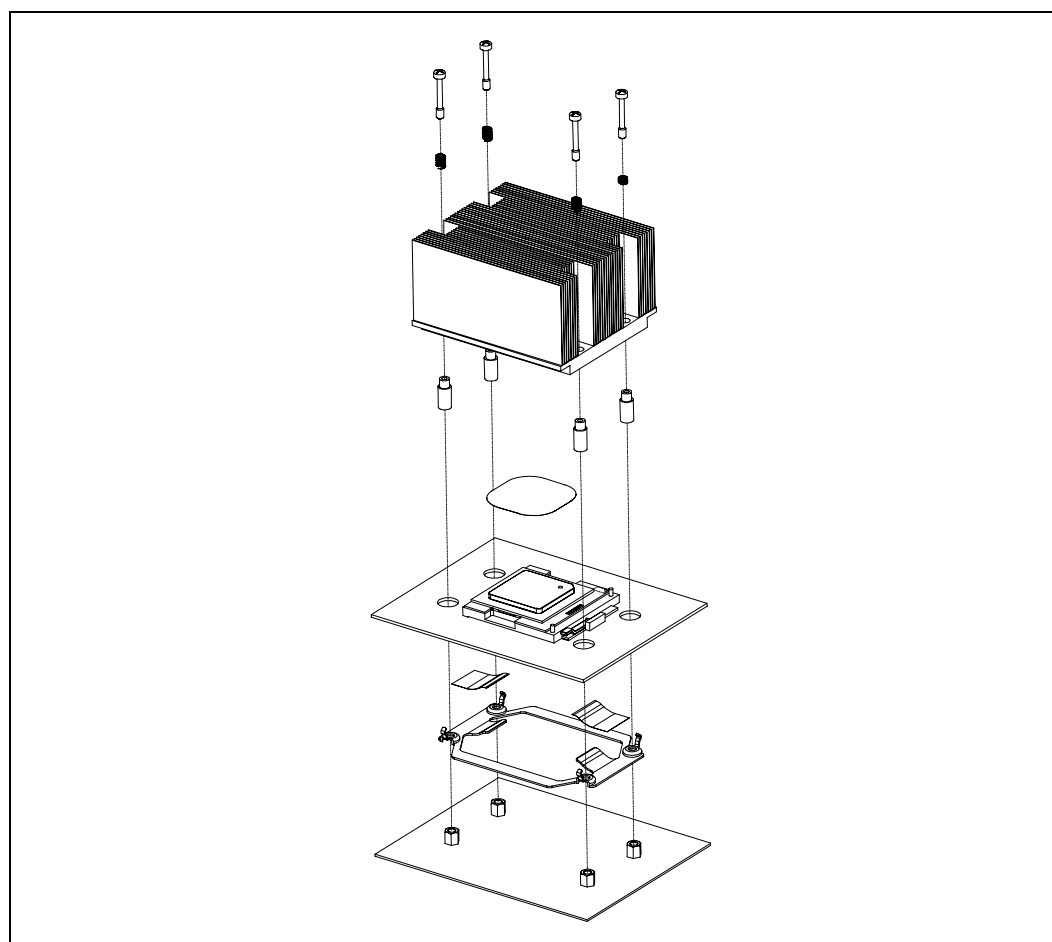
- Heatsink (with captive standoff and screws)
- Thermal Interface Material (TIM)
- CEK Spring

2.5.4.1 Geometric Envelope

The baseboard keepout zones on the primary and secondary sides and height restrictions under the enabling component region are shown in detail in [Appendix B](#). The overall volumetric keep in zone encapsulates the processor, socket, and the entire thermal/mechanical enabling solution.

2.5.4.2 Assembly Drawing

Figure 2-16. Exploded View of CEK Thermal Solution Components





The CEK reference thermal solution is designed to extend air-cooling capability through the use of larger heatsinks with minimal airflow blockage and bypass. CEK retention solution can allow the use of much heavier heatsink masses compared to the legacy limits by using a load path directly attached to the chassis pan. The CEK spring on the secondary side of the baseboard provides the necessary compressive load for the thermal interface material. The baseboard is intended to be isolated such that the dynamic loads from the heatsink are transferred to the chassis pan via the stiff screws and standoffs. This reduces the risk of package pullout and solder-joint failures.

Using the CEK reference thermal solution, Intel recommends that the maximum outside diameter dimension of the chassis pan standoffs, regardless of shape, that interfaces with the CEK spring on the secondary side of the baseboard and captive screws on the primary side of the baseboard to attach the heatsink to the chassis pan should be no larger than 7.112 mm [0.28 in.]. For example, circular standoffs should be no larger than 7.112 mm [0.28 in.] point-to-point.

The baseboard mounting holes for the CEK solution are at the same location as the hole locations used for previous Intel® Xeon® processor thermal solution. However, CEK assembly requires 10.16 mm [0.400 in.] large diameter holes to compensate for the CEK spring embosses.

The CEK solution is designed and optimized for a baseboard thickness range of 1.57 – 2.31 mm [0.062-0.093 in]. While the same CEK spring can be used for this board thickness range, the heatsink standoff height is different for a 1.57 mm [0.062 in] thick board than it is for a 2.31 mm [0.093 in] thick board. In the heatsink assembly, the standoff protrusion from the base of the heatsink needs to be 0.6 mm [0.024 in] longer for a 2.31 mm [0.093 in] thick board, compared to a 1.57 mm [0.062 in] thick board. If this solution is intended to be used on baseboards that fall outside of this range, then some aspects of the design, including but not limited to the CEK spring design and the standoff heights, may need to change. Therefore, system designers need to evaluate the thermal performance and mechanical behavior of the CEK design on baseboards with different thicknesses.

Refer to [Appendix B](#) for drawings of the heatsinks and CEK spring. The screws and standoffs are standard components that are made captive to the heatsink for ease of handling and assembly.

Contact your Intel field sales representative for an electronic version of mechanical and thermal models of the CEK (Pro/Engineer*, IGES and Icepak*, Flotherm* formats). Pro/Engineer, Icepak and Flotherm models are available on Intel Business Link (IBL).

Note: Intel reserves the right to make changes and modifications to the design as necessary.

Note: The thermal mechanical reference design for the Quad-Core Intel® Xeon® Processor 5400 Series was verified according to the Intel validation criteria given in [Appendix E.1](#). Any thermal mechanical design using some of the reference components in combination with any other thermal mechanical solution needs to be fully validated according to the customer criteria. Also, if customer thermal mechanical validation criteria differ from the Intel criteria, the reference solution should be validated against the customer criteria.

2.5.4.3 Structural Considerations of CEK

As Intel explores methods of keeping thermal solutions within the air-cooling space, the mass of the thermal solutions is increasing. Due to the flexible nature (and associated large deformation) of baseboard-only attachments, Intel reference solutions, such as

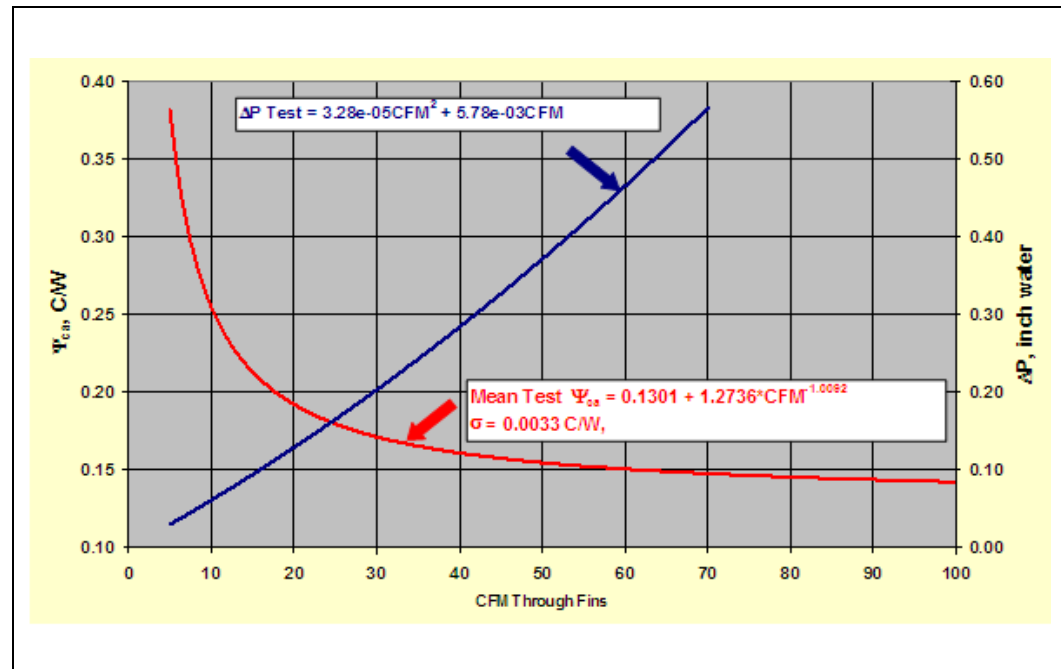


CEK, are now commonly using direct chassis attach (DCA) as the mechanical retention design. The mass of the new thermal solutions is large enough to require consideration for structural support and stiffening on the chassis.

2.5.5 Thermal Solution Performance Characteristics

Figure 2-17 and Figure 2-18 show the performance of the 2U+ and 1U passive heatsinks, respectively. These figures show the thermal performance and the pressure drop through fins of the heatsink versus the airflow provided. The best-fit equations for these curves are also provided to make it easier for users to determine the desired value without any error associated with reading the graph.

Figure 2-17. 2U+ CEK Heatsink Thermal Performance



If other custom heatsinks are intended for use with the Quad-Core Intel® Xeon® Processor 5400 Series, they must support the following interface control requirements to be compatible with the reference mechanical components:

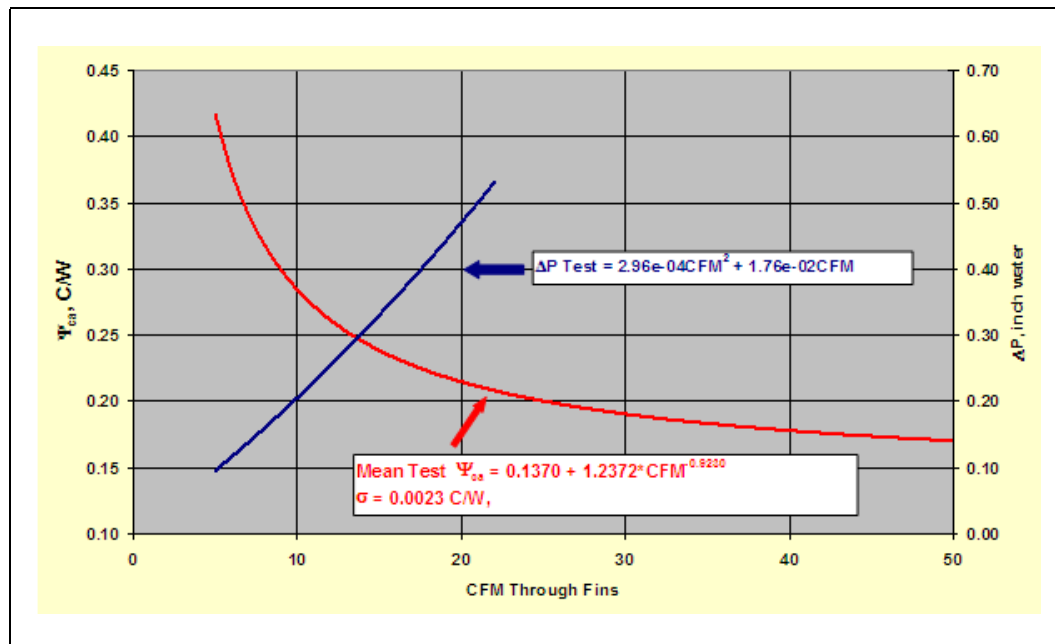
- **Requirement 1:** Heatsink assembly must stay within the volumetric keep-in.
- **Requirement 2:** Maximum mass and center of gravity.

Current maximum heatsink mass is 1000 grams [2.2 lbs] and the maximum center of gravity 3.81 cm [1.5 in.] above the bottom of the heatsink base.

- **Requirement 3:** Maximum and minimum compressive load.

Any custom thermal solution design must meet the loading specification as documented within this document, and should refer to the *Quad-Core Intel® Xeon® Processor 5400 Series Datasheet* and *LGA771 Socket Mechanical Design Guide* for specific details on package/socket loading specifications.

Figure 2-18. 1U CEK Heatsink Thermal Performance



2.5.6 Thermal Profile Adherence

The 2U+ CEK Intel reference thermal solution is designed to meet the Thermal Profile A for the Quad-Core Intel® Xeon® Processor 5400 Series. From Table 2-4, the three-sigma (mean+3sigma) performance of the thermal solution is computed to be 0.187 °C/W and the processor local ambient temperature (T_{LA}) for this thermal solution is 40 °C. Hence, the Thermal Profile equation for this thermal solution is calculated as:

Equation 2-8. $y = 0.187 \cdot X + 40$

where,

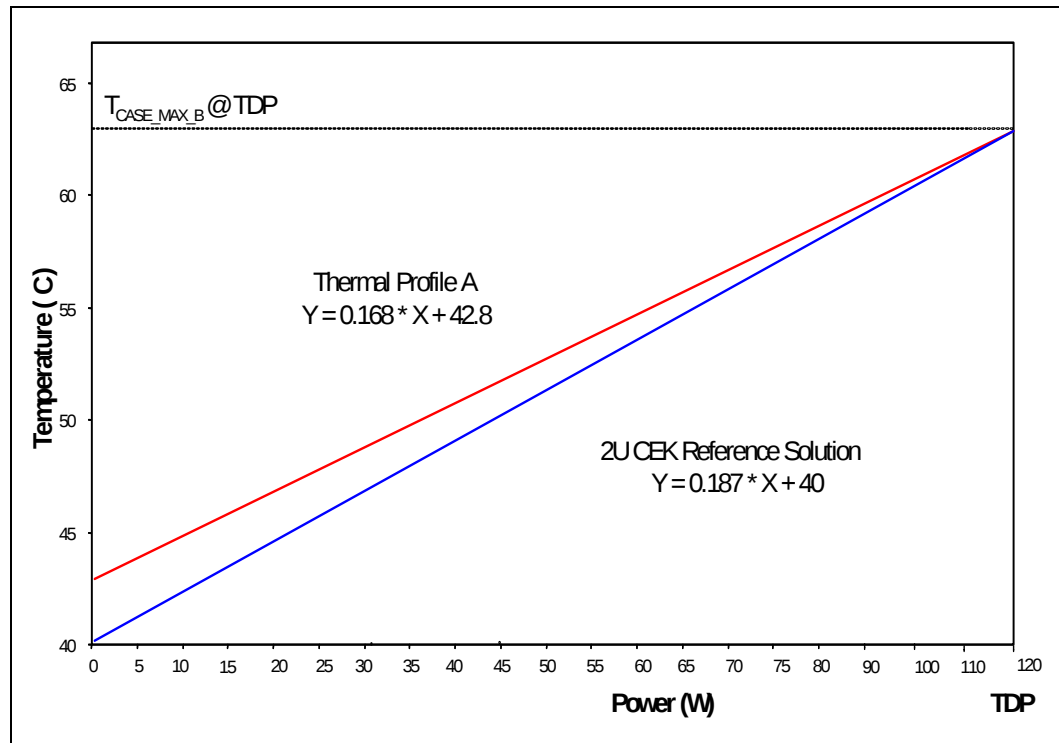
y = Processor T_{CASE} value (°C)

x = Processor power value (W)

Figure 2-19 below shows the comparison of this reference thermal solution's Thermal Profile to the Quad-Core Intel® Xeon® Processor 5400 Series Thermal Profile A specification. The 2U+ CEK solution meets the Thermal Profile A with a 0.6°C margin at the upper end (TDP). By designing to Thermal Profile A, it is ensured that no measurable performance loss due to TCC activation is observed under the given environmental conditions.



Figure 2-19. 2U+CEK Thermal Adherence to Quad-Core Intel® Xeon® Processor X5400 Series Thermal Profile A



The 1U CEK Intel reference thermal solution is designed to meet the Thermal Profile B for the Quad-Core Intel® Xeon® Processor X5400 Series. From [Table 2-7](#) the three-sigma (mean+3sigma) performance of the thermal solution is computed to be 0.246°C/W and the processor local ambient temperature (T_{LA}) for this thermal solution is 40 °C. Hence, the Thermal Profile equation for this thermal solution is calculated as:

Equation 2-9. $y = 0.246 * X + 40$

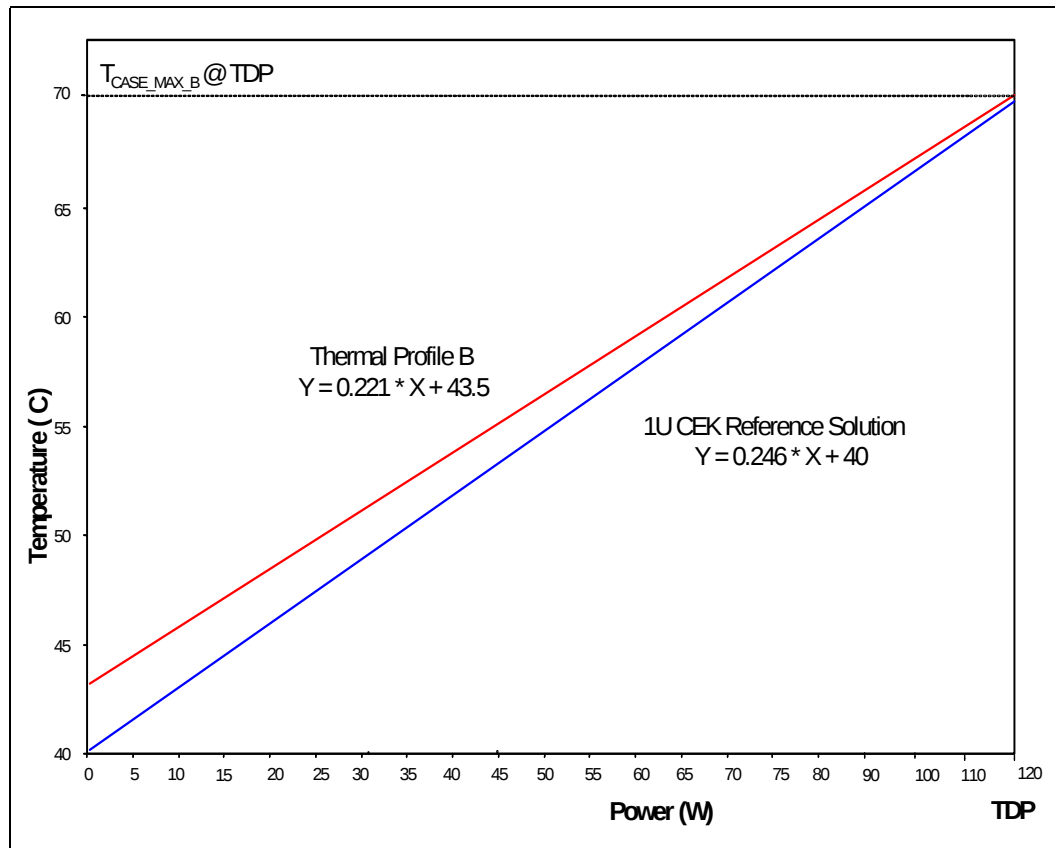
where,

y = Processor T_{CASE} value (°C)

x = Processor power value (W)

[Figure 2-20](#) below shows the comparison of this reference thermal solution's Thermal Profile to the Quad-Core Intel® Xeon® Processor X5400 Series Thermal Profile specification. The 1U CEK solution meets the Thermal Profile B with 0.5°C margin at the upper end (TDP). However, as explained in [Section 2.2.7](#), designing to Thermal Profile B results in increased TCC activation and measurable performance loss for the processor.

Figure 2-20. 1U CEK Thermal Adherence to Quad-Core Intel® Xeon® Processor X5400 Series Thermal Profile B



The 1U CEK Intel reference thermal solution is designed to meet the Thermal Profile specification for the Quad-Core Intel® Xeon® Processor E5400 Series. From [Table 2-7](#) the three-sigma (mean+3sigma) performance of the thermal solution is computed to be 0.246 °C/W and the processor local ambient temperature (T_{LA}) for this thermal solution is 40 °C. Hence, the Thermal Profile equation for this thermal solution is calculated as:

Equation 2-10. $y = 0.246 * X + 40$

where,

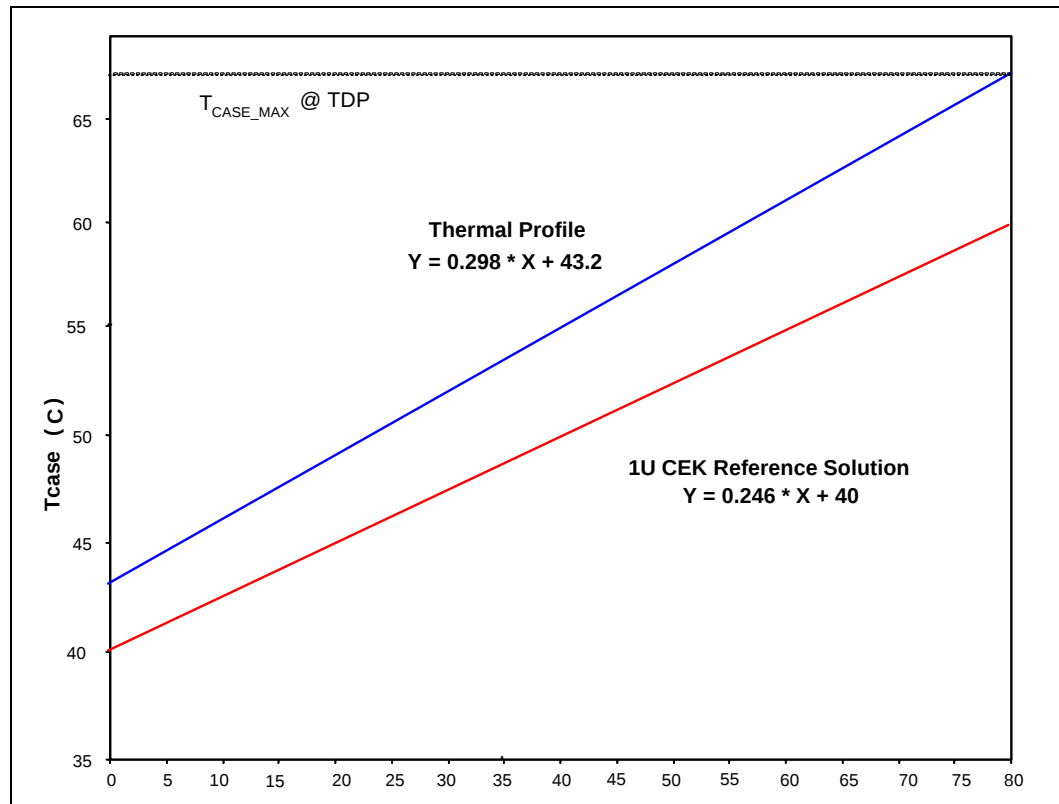
y = Processor T_{CASE} value (°C)

x = Processor power value (W)

[Figure 2-21](#) below shows the comparison of this reference thermal solution's Thermal Profile to the Quad-Core Intel® Xeon® Processor E5400 Series Thermal Profile specification. The 1U CEK solution meets the Thermal Profile with 7.3°C margin at the upper end (TDP). By designing to Quad-Core Intel® Xeon® Processor E5400 Series Thermal Profile, it is ensured that no measurable performance loss due to TCC activation is observed under the given environmental conditions.



Figure 2-21. 1U CEK Thermal Adherence to Quad-Core Intel® Xeon® Processor E5400 Series Thermal Profile



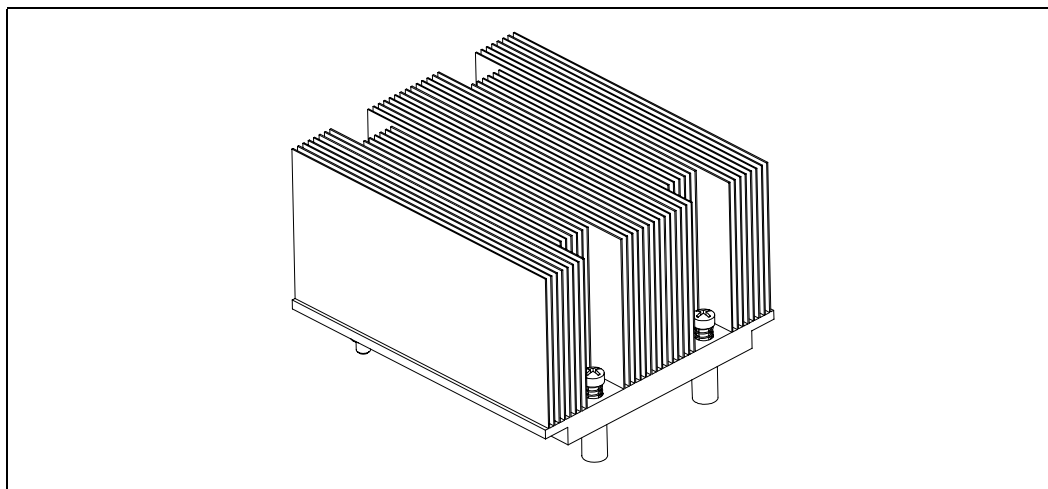
Note: Intel has also developed an 1U alternative reference heatsink design. This alternative heatsink design meets the thermal profile specifications of the Quad-Core Intel® Xeon® Processor E5400 Series and offers the advantages of weight reduction and cost savings. Refer to [Appendix B](#) for detail information.

2.5.7 Components Overview

2.5.7.1 Heatsink with Captive Screws and Standoffs

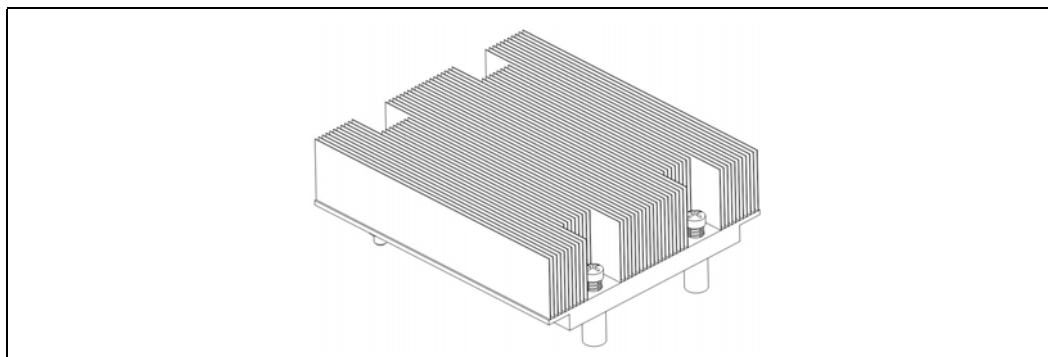
The CEK reference heatsink uses snapped-fin technology for its design. It consists of a copper base and copper fins with Shin-Etsu* G751 thermal grease as the TIM. The mounting screws and standoffs are also made captive to the heatsink base for ease of handling and assembly as shown in [Figure 2-22](#) and [Figure 2-23](#) for the 2U+ and 1U heatsinks, respectively.

Figure 2-22. Isometric View of the 2U+ CEK Heatsink



Note: Refer to [Appendix B](#) for more detailed mechanical drawings of the heatsink.

Figure 2-23. Isometric View of the 1U CEK Heatsink



Note: Refer to [Appendix B](#) for more detailed mechanical drawings of the heatsink.

The function of the standoffs is to provide a bridge between the chassis and the heatsink for attaching and load carrying. When assembled, the heatsink is rigid against the top of the standoff, and the standoff is rigid to a chassis standoff with the CEK spring firmly sandwiched between the two. In dynamic loading situations the standoff carries much of the heatsink load, especially in lateral conditions, when compared to the amount of load transmitted to the processor package. As such, it is comprised of steel. The distance from the bottom of the heatsink to the bottom of the standoff is 8.79 mm [0.346 in.] for a board thickness of 1.57 mm [0.062 in]. The standoff will need to be modified for use in applications with a different board thickness, as defined in [Section 2.5.4.2](#).

The function of the screw is to provide a rigid attach method to sandwich the entire CEK assembly together, activating the CEK spring under the baseboard, and thus providing the TIM preload. A screw is an inexpensive, low profile solution that does not negatively impact the thermal performance of the heatsink due to air blockage. Any fastener (i.e. head configuration) can be used as long as it is of steel construction; the head does not interfere with the heatsink fins, and is of the correct length of 20.64 mm [0.8125 in.].



Although the CEK heatsink fits into the legacy volumetric keep-in, it has a larger footprint due to the elimination of retention mechanism and clips used in the older enabled thermal/mechanical components. This allows the heatsink to grow its base and fin dimensions, further improving the thermal performance. A drawback of this enlarged size and use of copper for both the base and fins is the increased weight of the heatsink. The retention scheme employed by CEK is designed to support heavy heatsinks (approximately up to 1000 grams) in cases of shock, vibration and installation as explained in [Appendix E](#). Some of the thermal and mechanical characteristics of the CEK heatsinks are shown in [Table 2-7](#).

Table 2-7. CEK Heatsink Thermal Mechanical Characteristics

Size	Height	Weight	Target Airflow Through Fins	Mean Ψ_{ca}	Standard Deviation Ψ_{ca}	Pressure Drop
	(mm) [in.]	(kg) [lbs]	(m ³ /hr) [CFM]	(°C/W)	(°C/W)	(Pa) [in H ₂ O]
2U+	50.80 [2.00]	1.0 [2.2]	45.9 [27]	0.177	0.0033	45.3 [0.182]
1U	27.00 [1.06]	0.53 [1.2]	25.5 [15]	0.240	0.0023	82.4 [0.331]

2.5.7.2 Thermal Interface Material (TIM)

A TIM must be applied between the package and the heatsink to ensure thermal conduction. The CEK reference design uses Shin-Etsu G751 thermal grease.

The recommended grease dispense weight to ensure full coverage of the processor IHS is given below. For an alternate TIM, full coverage of the entire processor IHS is recommended.

Table 2-8. Recommended Thermal Grease Dispense Weight

Processor	Minimum	Maximum	Units	Notes
TIM Dispense weight		400	mg	Shin-Etsu* G751. Dispense weight is an approximate target.
TIM loading provided by CEK	18 80	30 133	lbf N	Generated by the CEK.

It is recommended that you use thermally conductive grease. Thermally conductive grease requires special handling and dispense guidelines. The following guidelines apply to Shin-Etsu G751 thermal grease. For guidance with your specific application, please contact the vendor. Vendor information is provided in [Appendix F](#). The use of a semi-automatic dispensing system is recommended for high volume assembly to ensure an accurate amount of grease is dispensed on top of the IHS prior to assembly of the heatsink. A typical dispense system consists of an air pressure and timing controller, a hand held output dispenser, and an actuation foot switch. Thermal grease in cartridge form is required for dispense system compatibility. A precision scale with an accuracy of ± 5 mg is recommended to measure the correct dispense weight and set the corresponding air pressure and duration. The IHS surface should be free of foreign materials prior to grease dispense.

Additional recommendations include recalibrating the dispense controller settings after any two hour pause in grease dispense. The grease should be dispensed just prior to heatsink assembly to prevent any degradation in material performance. Finally, the thermal grease should be verified to be within its recommended shelf life before use.

The CEK reference solution is designed to apply a compressive load of up to 133 N [30 lbf] on the TIM to improve the thermal performance.

2.5.7.3 CEK Spring

The CEK spring, which is attached on the secondary side of the baseboard, is made from 0.80 mm [0.0315 in.] thick 301 stainless steel half hard. Any future versions of the spring will be made from a similar material. The CEK spring has four embosses which, when assembled, rest on the top of the chassis standoffs. The CEK spring is located between the chassis standoffs and the heatsink standoffs. The purpose of the CEK spring is to provide compressive preload at the TIM interface when the baseboard is pushed down upon it. This spring does not function as a clip of any kind. The two tabs on the spring are used to provide the necessary compressive preload for the TIM when the whole solution is assembled. The tabs make contact on the secondary side of the baseboard. In order to avoid damage to the contact locations on the baseboard, the tabs are insulated with a 0.127 mm [0.005 in.] thick Kapton* tape (or equivalent). [Figure 2-24](#) shows an isometric view of the CEK spring design.

Figure 2-24. CEK Spring Isometric View

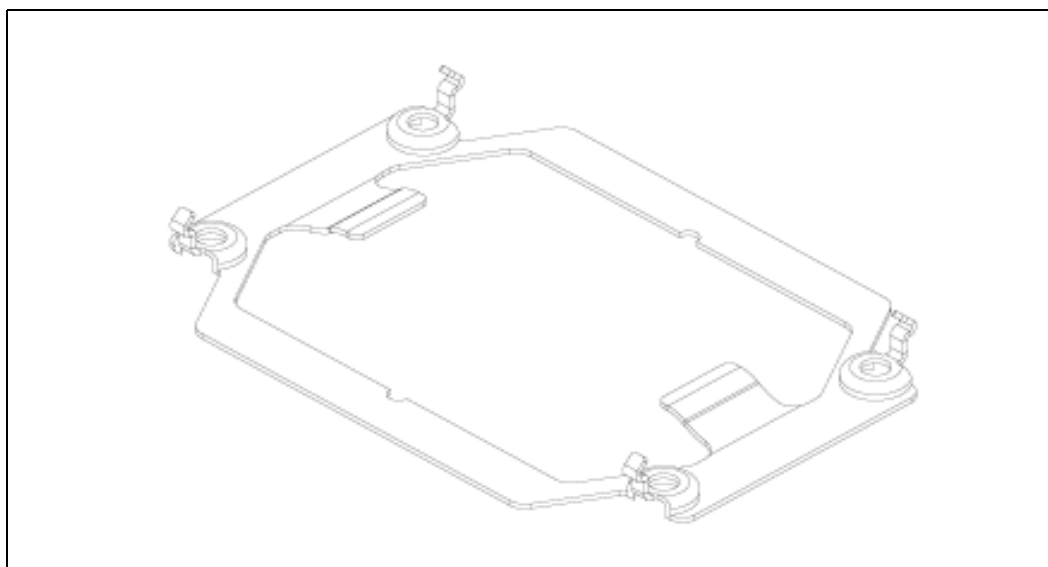
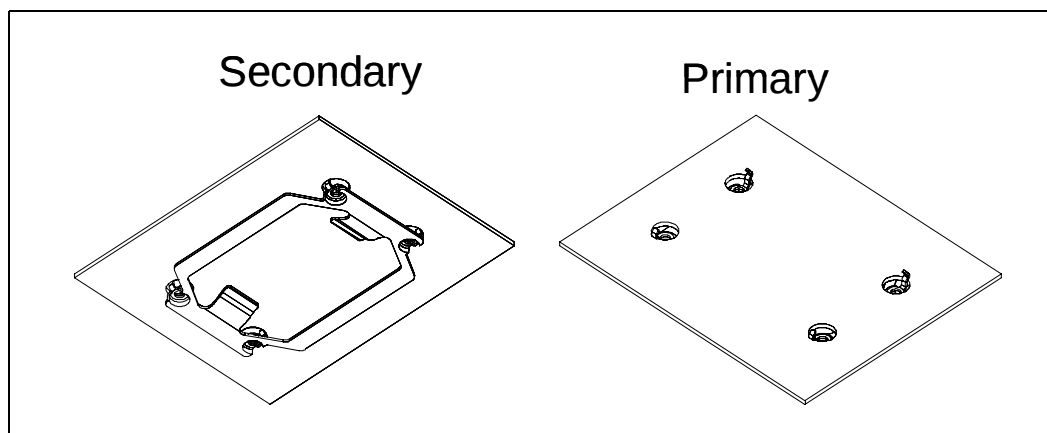
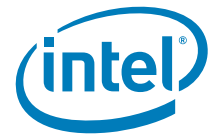


Figure 2-25. Isometric View of CEK Spring Attachment to the Base Board



Please refer to [Appendix B](#) for more detailed mechanical drawings of the CEK spring. Also, the baseboard keepout requirements shown in [Appendix B](#) must be met to use this CEK spring design.



2.5.8 Boxed Active Thermal Solution for the Quad-Core Intel® Xeon® Processor 5400 Series Thermal Profile

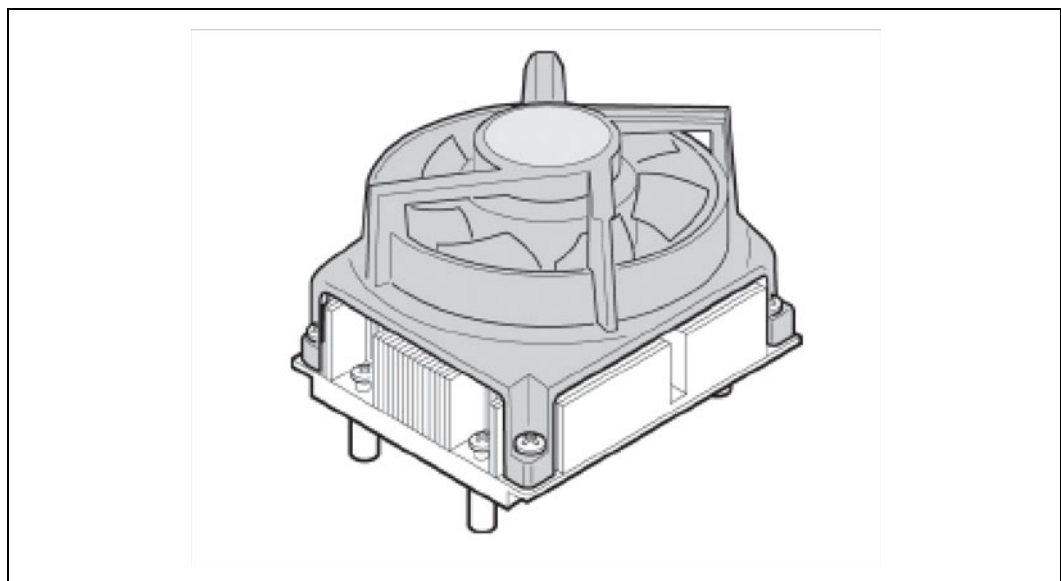
Intel will provide a 2U passive and a 1U passive/active heatsink solution for boxed Quad-Core Intel® Xeon® Processor 5400 Series. This active heatsink solution is primarily designed to be used in a pedestal chassis where sufficient air inlet space is present and side directional airflow is not an issue. This active heatsink solution consists of a 4 wire PWM fan and a 1U passive heatsink compatible with 1U form factors both mechanically and thermally. These solutions are intended for system integrators who build systems from components available through distribution channels. The retention solution used for these products is called the CEK. The CEK base is compatible with all the heatsink solutions.

Figure 2-26 provides a representation of the active CEK solution. This design is based on a 4-pin PWM PECI/DTS controlled active fan heatsink solution. PWM (Pulse Width Modulation also synonymous with Pulse Duration Modulation PDM) is a modulation in which the duration of pulse is varied in accordance with some characteristic of the modulating signal. This solution is being offered to help provide better control over pedestal chassis acoustics. This is achieved through accurate measurement of processor temperature through the processor's Digital Thermal Sensor (DTS) temperature. Fan RPM is modulated through the use of an ASIC (Application Specific Integrated Circuit) located on the serverboard, that sends out a PWM control signal to the 4th pin of the connector labeled as Control.

This heatsink solution also requires a constant +12 V supplied to pin 2 and does not support variable voltage control or 3-pin PWM control. If no PWM signal is detected on the 4th pin this heatsink solution will revert back to thermistor control mode, supporting both the 4-wire PWM and standard 3-wire ambient air control methods.

The active heatsink solution will not exceed a mass of approximately 1050 grams. Note that this is per processor, so a dual processor system will have up to approximately 2100 grams total mass in the heatsinks. This large mass will require a minimum chassis stiffness to be met in order to withstand force during shock and vibration.

Figure 2-26. Boxed Active CEK Heatsink Solutions with PWM/DTS Control (Representation Only)



Clearance is required around the heatsink to ensure unimpeded airflow for proper cooling. The physical baseboard keepout requirements for the active solution are the same as the passive CEK solution shown in [Appendix B](#). Refer to [Figure B-18](#) through [Figure B-20](#) for additional details on the active CEK thermal solution volumetrics.

2.5.8.1 Fan Power Supply

The active heatsink includes a fan, which requires a +12 V power supply. Platforms must provide a matched fan power header to support the boxed processor. [Table 2-9](#) contains specifications for the input and output signals at the heatsink fan connector.

The fan outputs a SENSE signal, an open-collector output, which pulses at a rate of two pulses per fan revolution. A baseboard pull-up resistor provides VCC to match the baseboard-mounted fan speed monitor requirements, if applicable. Use of the SENSE signal is optional. If the SENSE signal is not used, pin 3 of the connector should be tied to GND.

It is recommended that a 4 pin fan header be used on the baseboard, in addition to, a control ASIC that can send a PWM signal to the active fan heatsink solution on the 4th pin, at a nominal 25 KHz frequency. If a 3-pin CPU fan header is used instead, the active fan heatsink solution will revert back to an automatic ambient air temperature control mode.

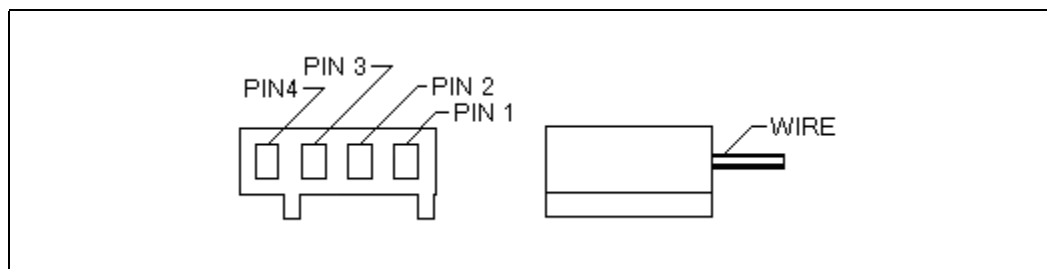
The fan power header on the baseboard must be positioned to allow the fan heatsink power cable to reach it. The fan power header identification and location must be documented in the supplier's platform documentation, or on the baseboard itself. The baseboard fan power header should be positioned within 177.8 mm [7 in.] from the center of the processor socket.

Table 2-9. Fan Specifications (Boxed 4-wire PWM/DTS Heatsink Solution)

Description	Min	Typ Steady	Max Steady	Max Startup	Unit	Notes
+12V: 12 Volt Fan Power Supply	10.8	12	12	13.2	V	
IC: Fan Current Draw	N/A	1.25	1.5	1.5	A	
SENSE: SENSE Frequency	2	2	2	2	Pulses per fan revolution	1

Note: System board should pull this pin up to V_{CC} with a resistor.

Figure 2-27. Fan Cable Connection (Active CEK)



**Table 2-10. Fan Cable Connector Pin Out (Active CEK)**

Pin Number	Signal	Color
1	Ground (Constant)	Black
2	Power (+12V)	Yellow
3	Signal: 2 pulses per revolution	Green
4	Control 21KHz - 28KHz	Blue

2.5.8.2 Systems Considerations Associated with the Active CEK

This heatsink was designed to help pedestal chassis users to meet the processor thermal requirements without the use of chassis ducting. It may be necessary to implement some form of chassis air guide or air duct to meet the T_{LA} temperature of 40 °C depending on the pedestal chassis layout. Also, while the active heatsink solution is designed to mechanically fit into a 2U chassis, it may require additional space at the top of the heatsink to allow sufficient airflow into the heatsink fan. Therefore, additional design criteria may need to be considered if this heatsink is used in a 2U rack mount chassis, or in a chassis that has drive bay obstructions above the inlet to the fan heatsink.

Thermal Profile A should be used to help determine the thermal performance of the platform. The primary recommended control method for this solution is using pulse width modulation control. This control method requires the motherboard provide the correct PWM duty cycle to the active fan heatsink solution to properly follow the thermal profile. If no PWM signal is detected the active heatsink solution will default back to a thermistor controlled mode and the fan will automatically adjust fan RPM to meet the thermal profile.

It is critical to supply a constant +12 V to the fan header so that the active CEK heatsink solution can operate properly. If a system board has a jumper setting to select either a constant +12 V power to the fan header or a variable voltage, it is strongly recommended that the jumper be set by default to the constant +12 V setting.

It is recommended that the ambient air temperature outside of the chassis be kept at or below 35 °C. The air passing directly over the processor heatsink should not be preheated by other system components. Meeting the processor's temperature specification is the responsibility of the system integrator.

2.5.8.3 Boxed Processor Contents

A direct chassis attach method must be used to avoid problems related to shock and vibration, due to the weight of the heatsink required to cool the processor. The board must not bend beyond specification in order to avoid damage. The boxed processor contains the components necessary to solve both issues. The boxed processor will include the following items:

- Quad-Core Intel® Xeon® Processor 5400 Series
- Unattached heatsink solution
- 4 screws, 4 springs, and 4 heatsink standoffs (all captive to the heatsink)
- Thermal Interface Material (pre-applied on heatsink)
- Installation Manual
- Intel Inside® logo



The other items listed in [Figure 2-16](#) that are required to complete this solution will be shipped with either the chassis or boards. They are as follows:

- CEK Spring (supplied by baseboard vendors)
- Heatsink standoffs (supplied by chassis vendors)

§

A 1U Alternative Heatsink Thermal/Mechanical Design

Intel has also developed an 1U alternative reference heatsink design for the volumetrically constrained form factor and targeted for the rack-optimized and ultra dense SKUs. This alternative heatsink design meets the thermal profile specifications of the Quad-Core Intel® Xeon® Processor E5400 Series and offers the advantages of weight reduction and cost savings in using this alternative 1U heatsink.

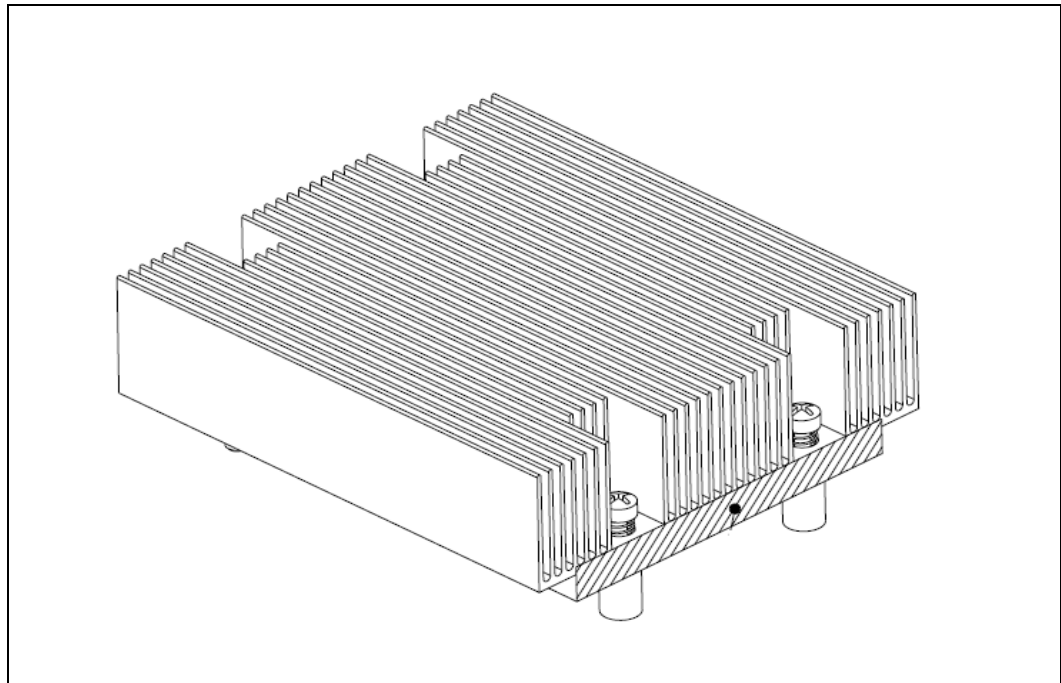
This section describes the alternative heatsink thermal performance and adherence to Quad-Core Intel® Xeon® Processor E5400 Series thermal profile specifications.

A.1 Component Overview

The alternative 1U reference heatsink is an extruded aluminum heatsink and shares the same volumetric footprint as the 1U CEK heatsink. It reuses Intel 1U CEK Captive standoff/screws, Thermal Interface Material (TIM) and Spring.

Figure A-1 shows the isometric view of the 1U alternative heatsink.

Figure A-1. Isometric View of the 1U Alternative Heatsink



Note: Refer to [Appendix B](#) for more detailed mechanical drawings of the heatsink.

A.2 Thermal Solution Performance Characteristics

Figure A-2 shows the performance of the 1U alternative heatsink. This figure shows the thermal performance and the pressure drop through fins of the heatsink versus the airflow provided. The best-fit equations for these curves are also provided to make it easier for users to determine the desired value without any error associated with reading the graph.

Figure A-2. 1U Alternative Heatsink Thermal Performance

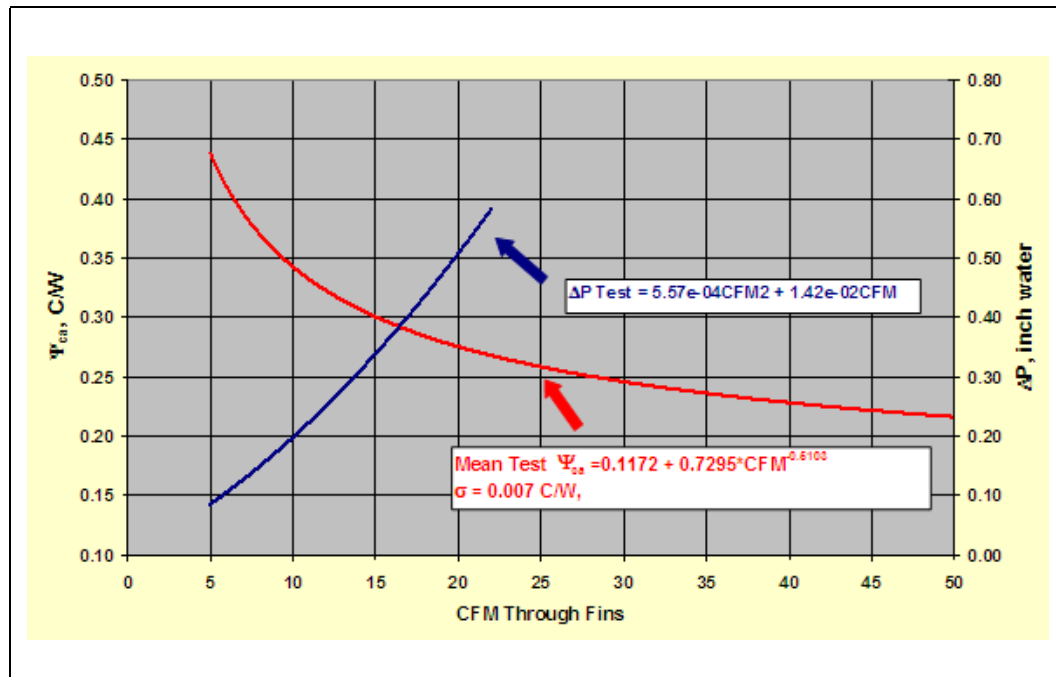


Table A-1. 1U Alternative Heatsink Thermal Mechanical Characteristics

Size	Height	Weight	Target Airflow Through Fins	Mean Ψ _{ca}	Standard Deviation Ψ _{ca}	Pressure Drop
	(mm) [in.]	(kg) [lbs]	(m ³ /hr) [CFM]	(°C/W)	(°C/W)	(Pa) [in H ₂ O]
1U	27.00 [1.06]	0.24 [0.53]	25.5 [15]	0.305	0.0087	85 [0.34]

A.3 Thermal Profile Adherence

The 1U alternative thermal solution is designed to meet the Thermal Profile for the Quad-Core Intel® Xeon® Processor E5400 Series in volumetrically constrained form factors. From Table A-1 the three-sigma (mean+3sigma) performance of the thermal solution is computed to be 0.331 °C/W and the processor local ambient temperature (T_{LA}) for this thermal solution is 40 °C. Hence, the Thermal Profile equation for this thermal solution is calculated as:

Equation A-1. $y = 0.331 \cdot x + 40$

where,

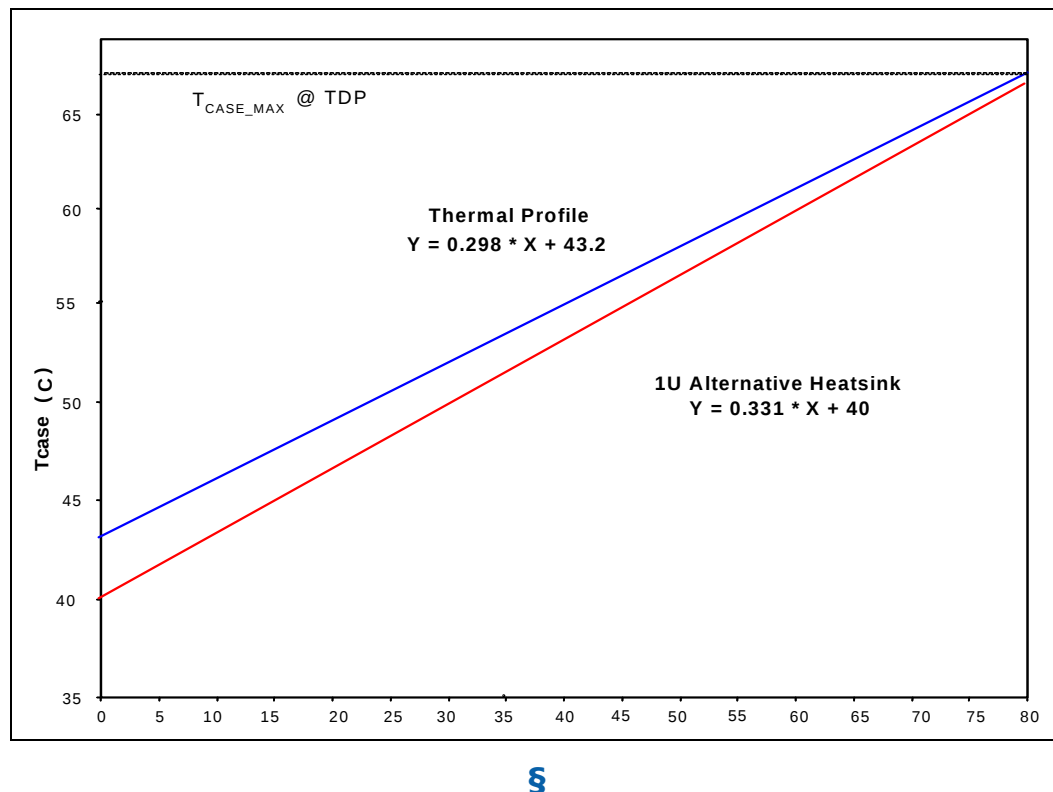
y = Processor T_{CASE} value (°C)



x = Processor power value (W)

Figure A-3 below shows the comparison of this reference thermal solution's Thermal Profile to the Quad-Core Intel® Xeon® Processor E5400 Series Thermal Profile specification. The 1U alternative solution meets the Thermal Profile with 0.5°C margin at the upper end (TDP). By designing to Thermal Profile, it is ensured that no measurable performance loss due to TCC activation is observed under the given environmental conditions.

Figure A-3. 1U Alternative Heatsink Thermal Adherence to Quad-Core Intel® Xeon® Processor L5400 Series Thermal Profile





1U Alternative Heatsink Thermal/Mechanical Design



B Mechanical Drawings

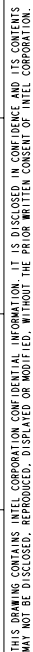
The mechanical drawings included in this appendix refer to the thermal mechanical enabling components for the Quad-Core Intel® Xeon® Processor 5400 Series.

Note: Intel reserves the right to make changes and modifications to the design as necessary.

Table B-1. Mechanical Drawing List

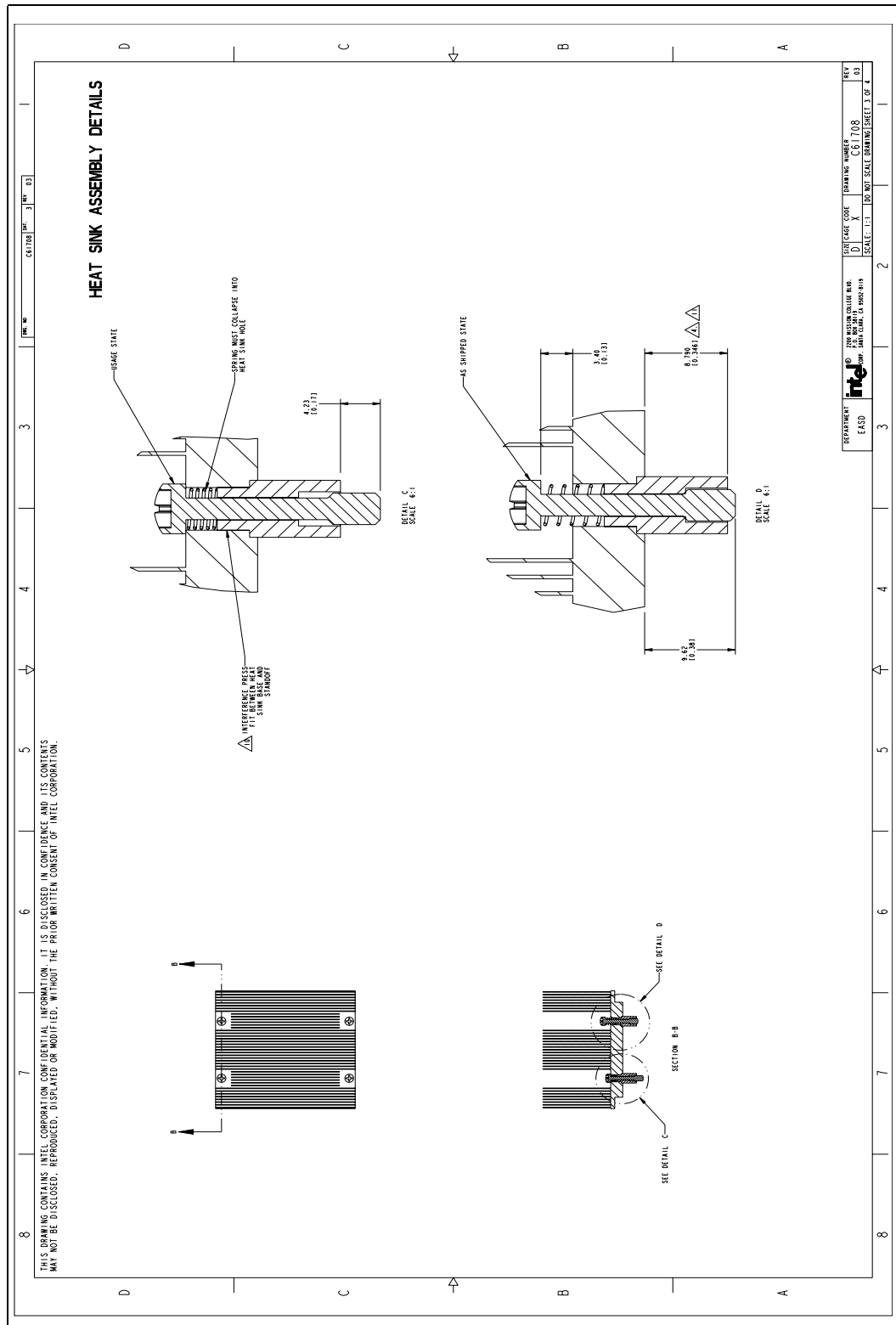
Drawing Description	Figure Number
"2U CEK Heatsink (Sheet 1 of 4)"	Figure B-1
"2U CEK Heatsink (Sheet 2 of 4)"	Figure B-2
"2U CEK Heatsink (Sheet 3 of 4)"	Figure B-3
"2U CEK Heatsink (Sheet 4 of 4)"	Figure B-4
"CEK Spring (Sheet 1 of 3)"	Figure B-5
"CEK Spring (Sheet 2 of 3)"	Figure B-6
"CEK Spring (Sheet 3 of 3)"	Figure B-7
"Baseboard Keepout Footprint Definition and Height Restrictions for Enabling Components (Sheet 1 of 6)"	Figure B-8
"Baseboard Keepout Footprint Definition and Height Restrictions for Enabling Components (Sheet 2 of 6)"	Figure B-9
"Baseboard Keepout Footprint Definition and Height Restrictions for Enabling Components (Sheet 3 of 6)"	Figure B-10
"Baseboard Keepout Footprint Definition and Height Restrictions for Enabling Components (Sheet 4 of 6)"	Figure B-11
"Baseboard Keepout Footprint Definition and Height Restrictions for Enabling Components (Sheet 5 of 6)"	Figure B-12
"Baseboard Keepout Footprint Definition and Height Restrictions for Enabling Components (Sheet 6 of 6)"	Figure B-13
"1U CEK Heatsink (Sheet 1 of 4)"	Figure B-14
"1U CEK Heatsink (Sheet 2 of 4)"	Figure B-15
"1U CEK Heatsink (Sheet 3 of 4)"	Figure B-16
"1U CEK Heatsink (Sheet 4 of 4)"	Figure B-17
"Active CEK Thermal Solution Volumetric (Sheet 1 of 3)"	Figure B-18
"Active CEK Thermal Solution Volumetric (Sheet 2 of 3)"	Figure B-19
"Active CEK Thermal Solution Volumetric (Sheet 3 of 3)"	Figure B-20
"1U Alternative Heatsink (1 of 4)"	Figure B-21
"1U Alternative Heatsink (2 of 4)"	Figure B-22
"1U Alternative Heatsink (3 of 4)"	Figure B-23
"1U Alternative Heatsink (4 of 4)"	Figure B-24

Quad-Core Intel® Xeon® Processor 5400 Series TMDG



[illegible]

Figure B-3. 2U CEK Heatsink (Sheet 3 of 4)



Quad-Core Intel® Xeon® Processor 5400 Series TMDG



Quad-Core Intel® Xeon® Processor 5400 Series TMDG

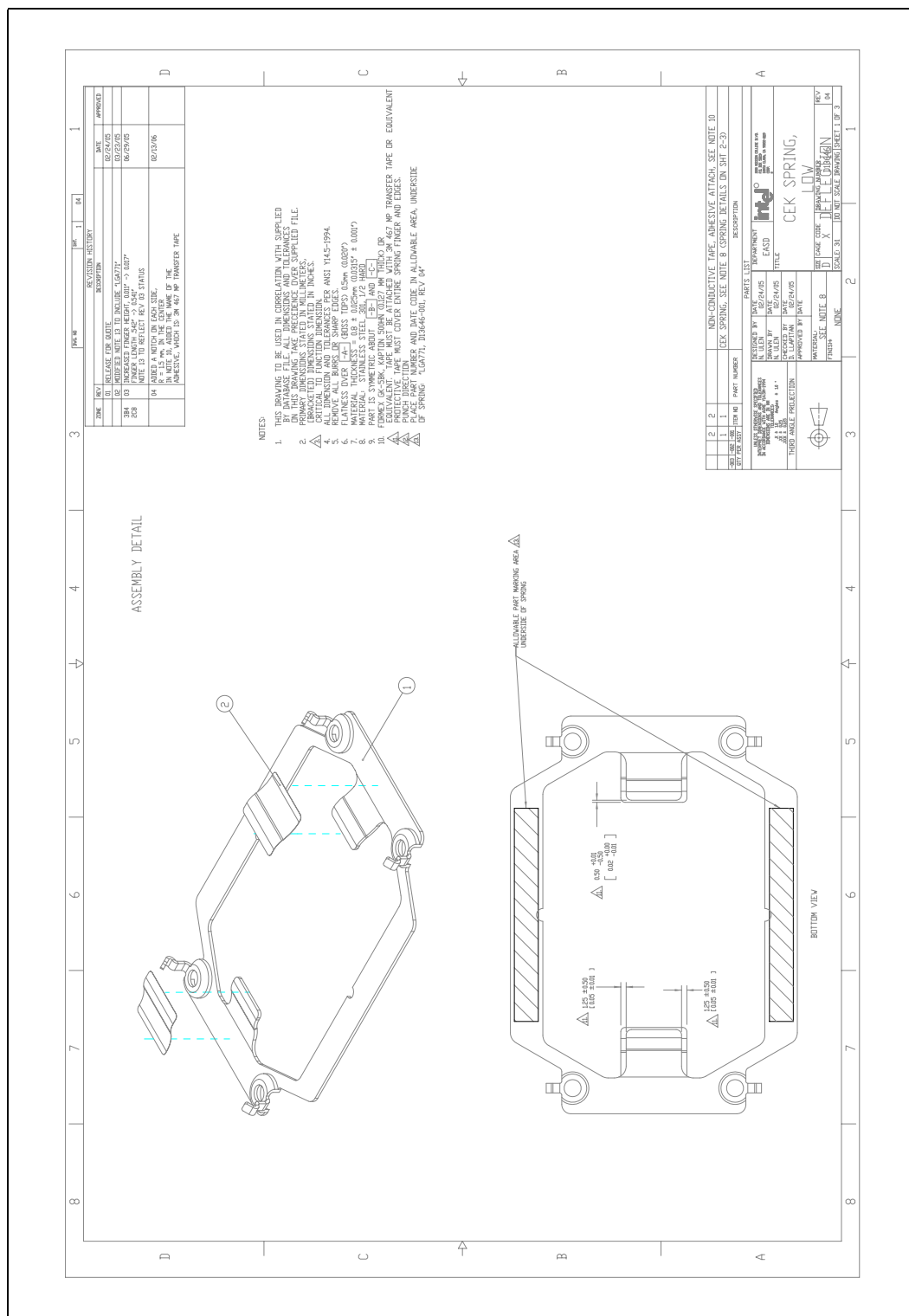
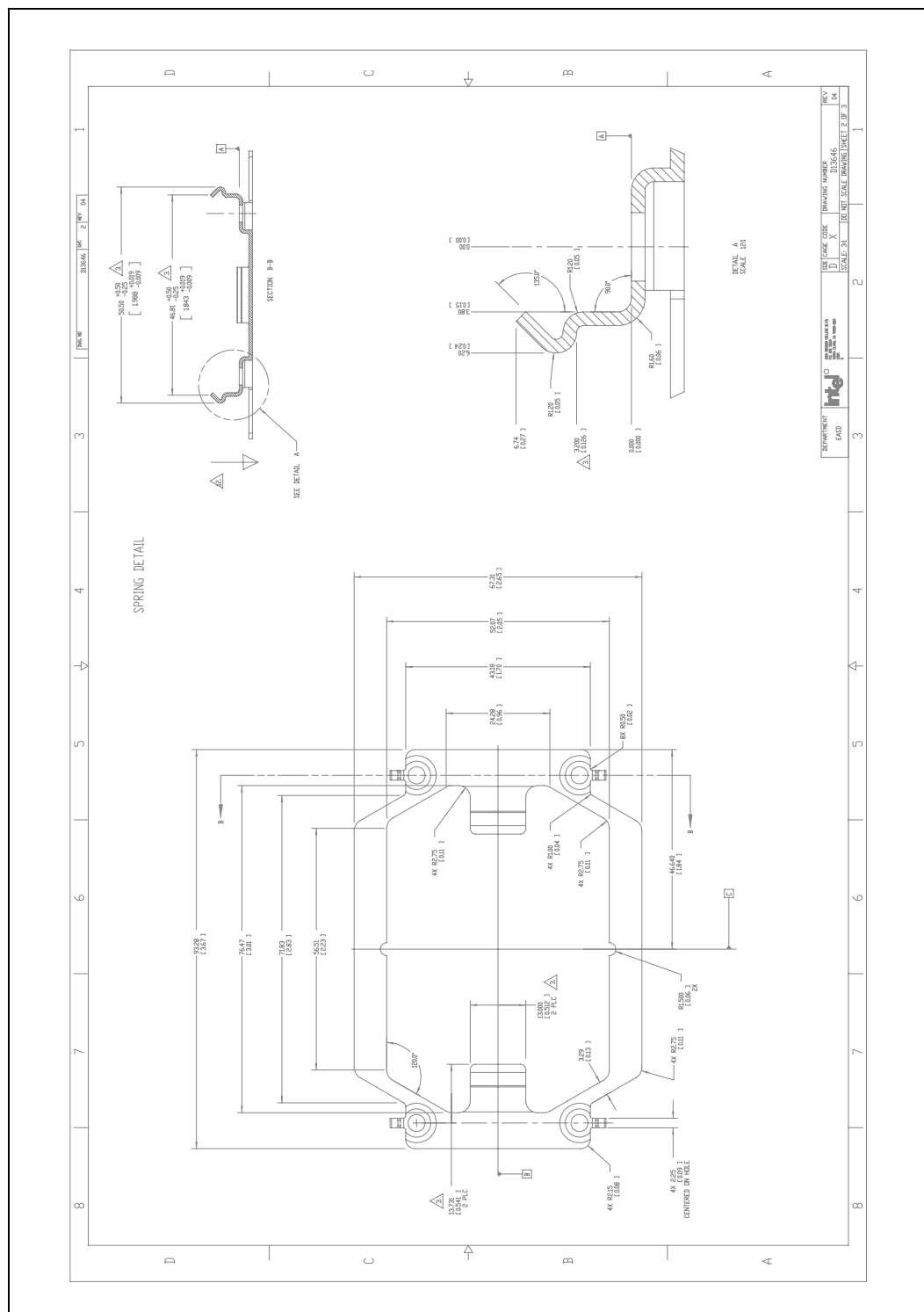


Figure B-6. CEK Spring (Sheet 2 of 3)



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INTEL CORP. 3180 N. MISSION AVENUE, SANTA CLARA, CA 95051-1609

DATE: 01/01/03 BY: [REDACTED] APPROVED: [REDACTED]

THIS DRAWING IS A PART OF THE INTEL CORPORATION DESIGN DOCUMENT. SEE SHEET 8 FOR BOM TABLE.

PRIMARY SIDE

AIR FLOW

TEST BOARD SHOWN FOR REFERENCE

HEATSINK DISASSEMBLY OUTLINE SEE SHT 2 FOR DIMS

HEATSINK OUTLINE SEE SHT 2 FOR DIMS

0.275" HEIGHT RESTRICTION

36.01 (1.418)

38.1 (1.500)

SOCKET J BOUNDARY FOR ILLUSTRATIVE PURPOSES ONLY.

SOCKET SOLDER BALL PERIMETER

SOLDER BALL Ø

HEATSINK DISASSEMBLY OUTLINE SEE SHT 2 FOR DIMS

HEATSINK OUTLINE SEE SHT 2 FOR DIMS

HEATSINK

0.118" (3.0 MM) MAX COMPONENT HEIGHT RESTRICTION.

HEATSINK AREA, 0.275" (7.0 MM) MAX COMPONENT HEIGHT RESTRICTION.

HEATSINK DISASSEMBLY AREA, 0.275" (7.0 MM) MAX COMPONENT HEIGHT RESTRICTION.

NO MOTHERBOARD COMPONENT PLACEMENT ALLOWED.

0.433" (11MM) MAX MOTHERBOARD COMPONENT HEIGHT RESTRICTION.

CEX SPRING BOARD FINGER KEYPOT, NO MOTHERBOARD COMPONENTS ALLOWED.

NOTES:

- THIS DRAWING TO BE USED IN CORRELATION WITH SUPPLIED 3D DATABASE FILE. ALL DIMENSIONS AND TOLERANCES ON THIS DRAWING TAKE PRECEDENCE OVER SUPPLIED FILE.
- PRIMARY DIMENSIONS STATED IN MILLIMETERS, (BRACKETED).
- THIS DIMENSION LOCATES THE SOCKET W.P.T.
- TO NOTE: VOLTAGE REGULATION KEYPOT WILL BE SHOWN ON SEPARATE DOCUMENT.
- SOCKET KEYPOT DIMENSIONS SHOWN FOR REFERENCE ONLY. REFER TO THE SOCKET J KEYPOT / KEEP IN DRAWING FOR EXACT DIMENSIONS.

LEGEND:

- 0.118" (3.0 MM) MAX COMPONENT HEIGHT RESTRICTION.
- HEATSINK AREA, 0.275" (7.0 MM) MAX COMPONENT HEIGHT RESTRICTION.
- HEATSINK DISASSEMBLY AREA, 0.275" (7.0 MM) MAX COMPONENT HEIGHT RESTRICTION.
- NO MOTHERBOARD COMPONENT PLACEMENT ALLOWED.
- 0.433" (11MM) MAX MOTHERBOARD COMPONENT HEIGHT RESTRICTION.
- CEX SPRING BOARD FINGER KEYPOT, NO MOTHERBOARD COMPONENTS ALLOWED.

REVISIONS:

REV	DATE	DESCRIPTION
1	01/01/03	ISSUED FOR FAB

DESIGNED BY: [REDACTED] DATE: 01/01/03
 DRAWN BY: [REDACTED] DATE: 01/01/03
 CHECKED BY: [REDACTED] DATE: 01/01/03
 APPROVED BY: [REDACTED] DATE: 01/01/03

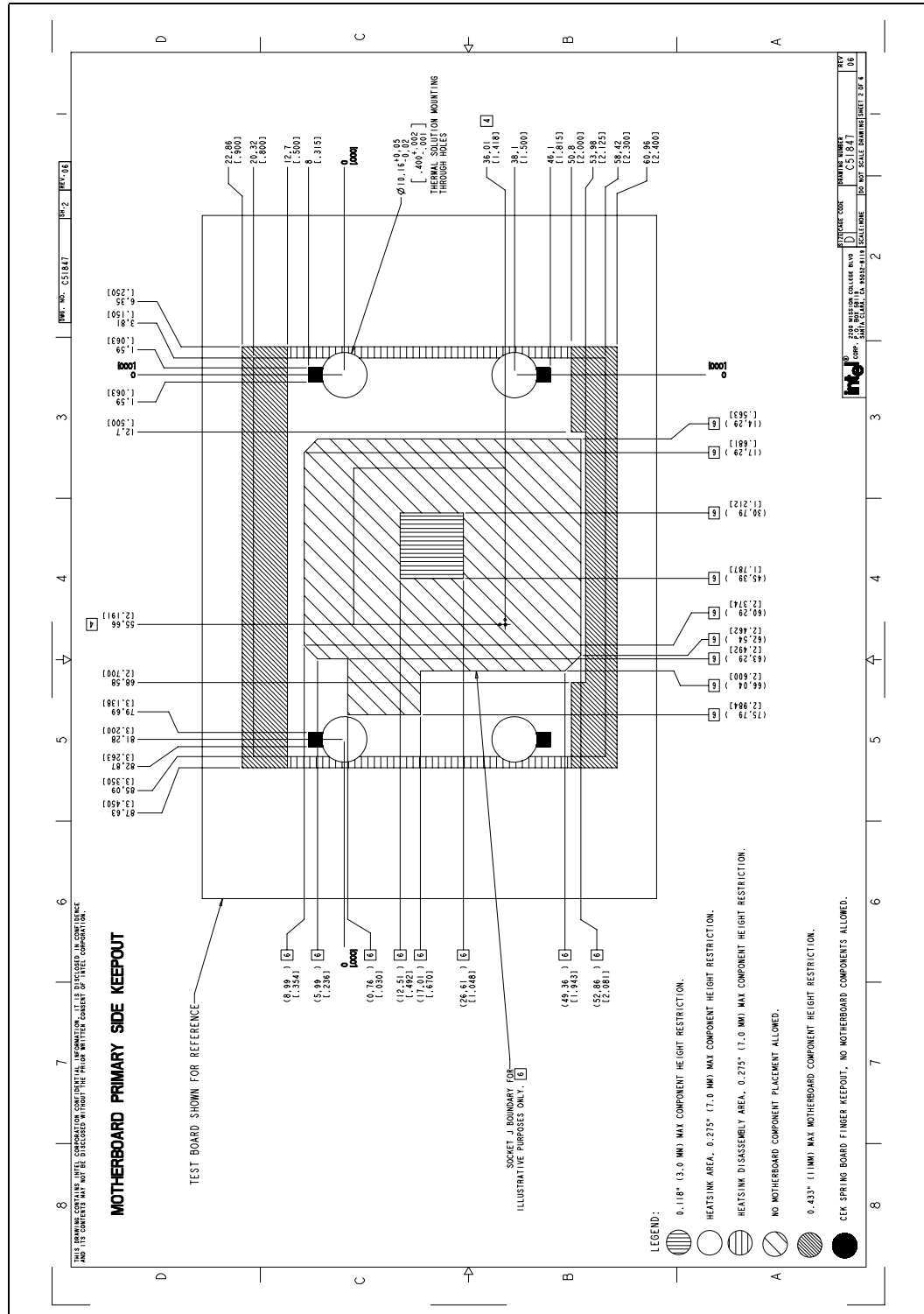
PROJECT: INTEL CORPORATION
 TITLE: SOCKET J KEYPOT / KEEP IN
 MATERIAL: [REDACTED]
 FINISH: [REDACTED]

INTEL CORPORATION
 3180 N. MISSION AVENUE, SANTA CLARA, CA 95051-1609

CEX ENABLING KEYPOT / KEEP IN
 SOCKET J VERSION

DATE: 01/01/03
 DRAWING NUMBER: CS1847
 SHEET: 8 OF 8

Figure B-9. Baseboard Keepout Footprint Definition and Height Restrictions for Enabling Components (Sheet 2 of 6)



Quad-Core Intel® Xeon® Processor 5400 Series TMDG



Figure B-11. Baseboard Keepout Footprint Definition and Height Restrictions for Enabling Components (Sheet 4 of 6)

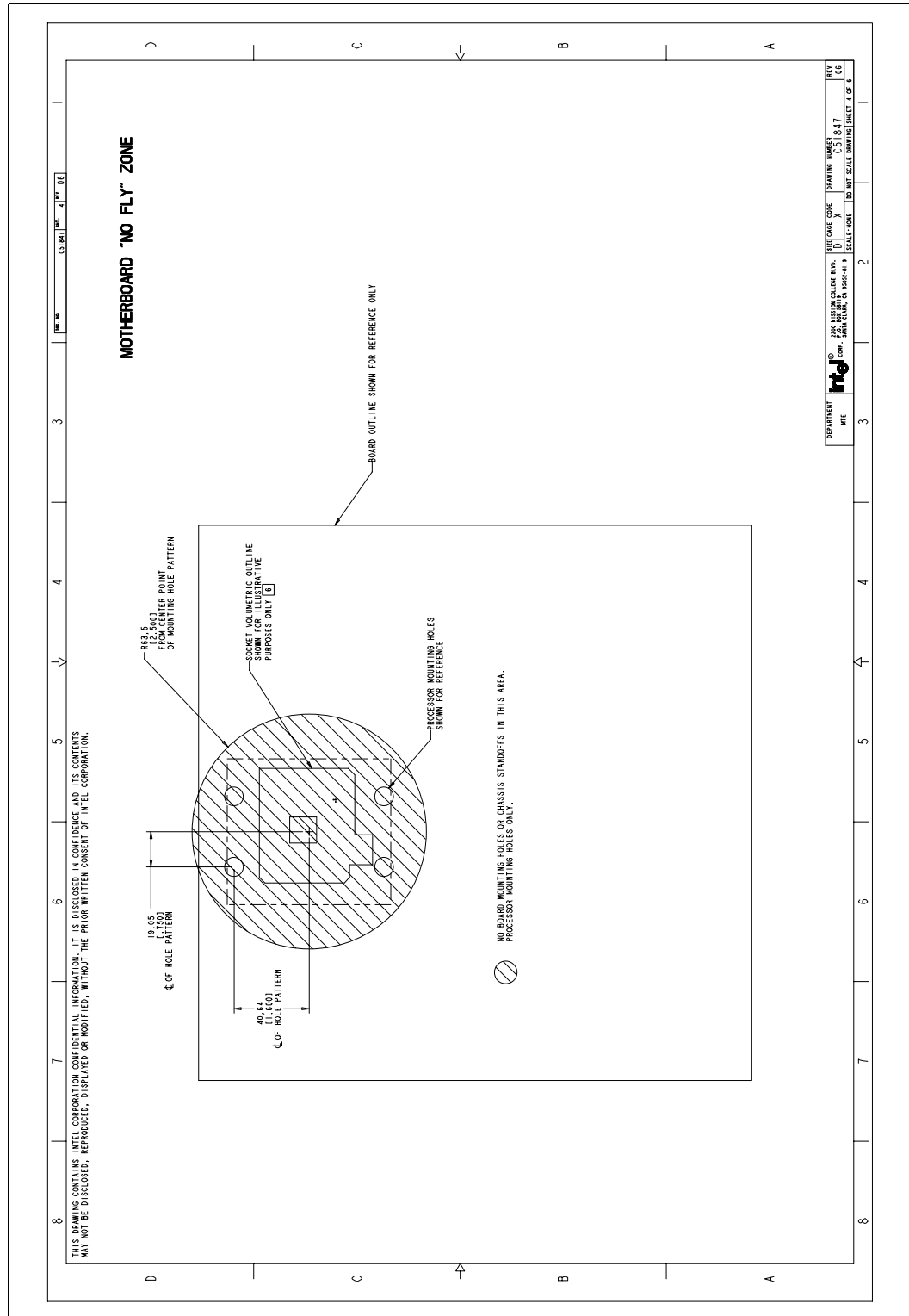
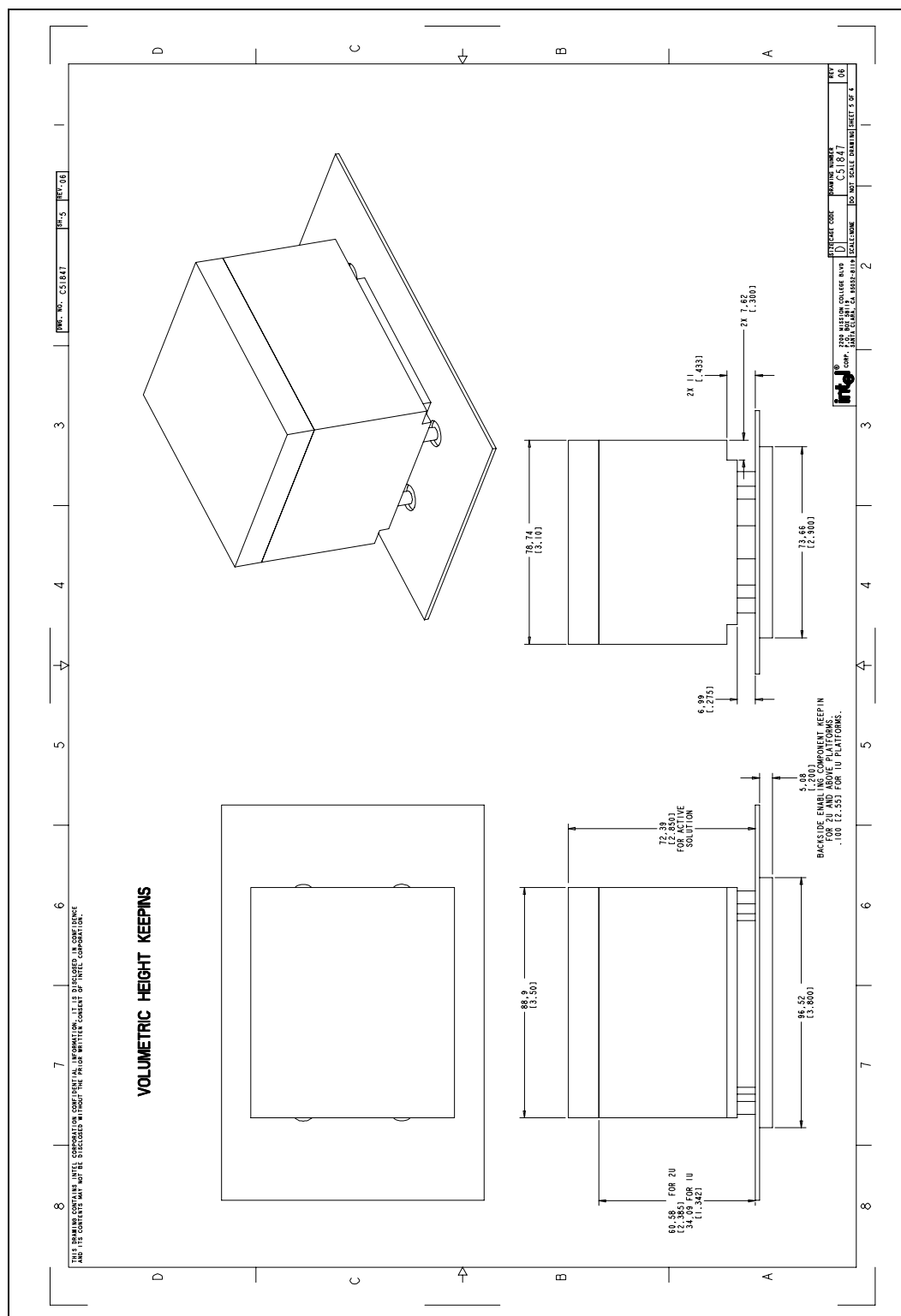


Figure B-12. Baseboard Keepout Footprint Definition and Height Restrictions for Enabling Components (Sheet 5 of 6)



[illegible]

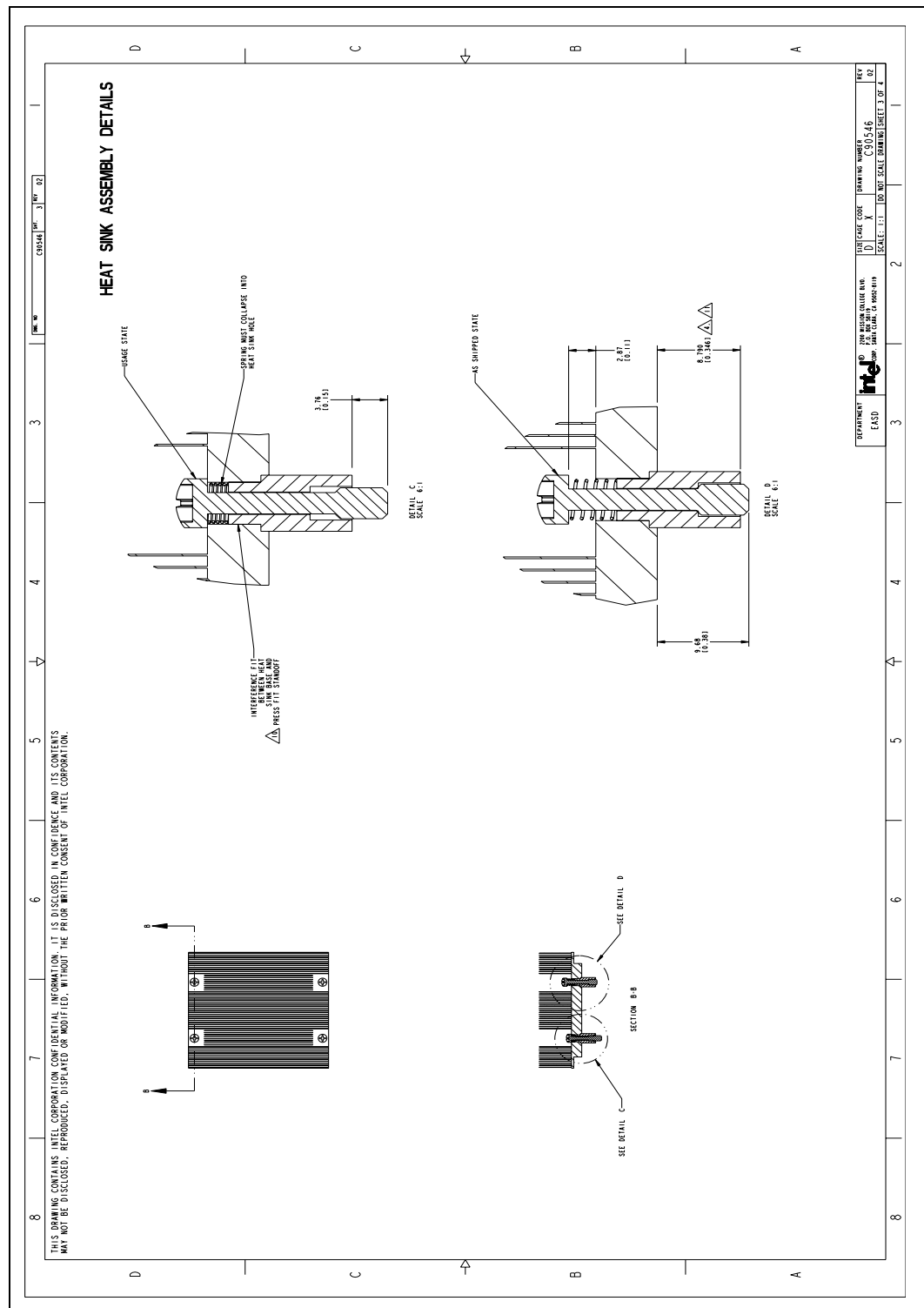
Quad-Core Intel® Xeon® Processor 5400 Series TMDG



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Figure B-16. 1U CEK Heatsink (Sheet 3 of 4)

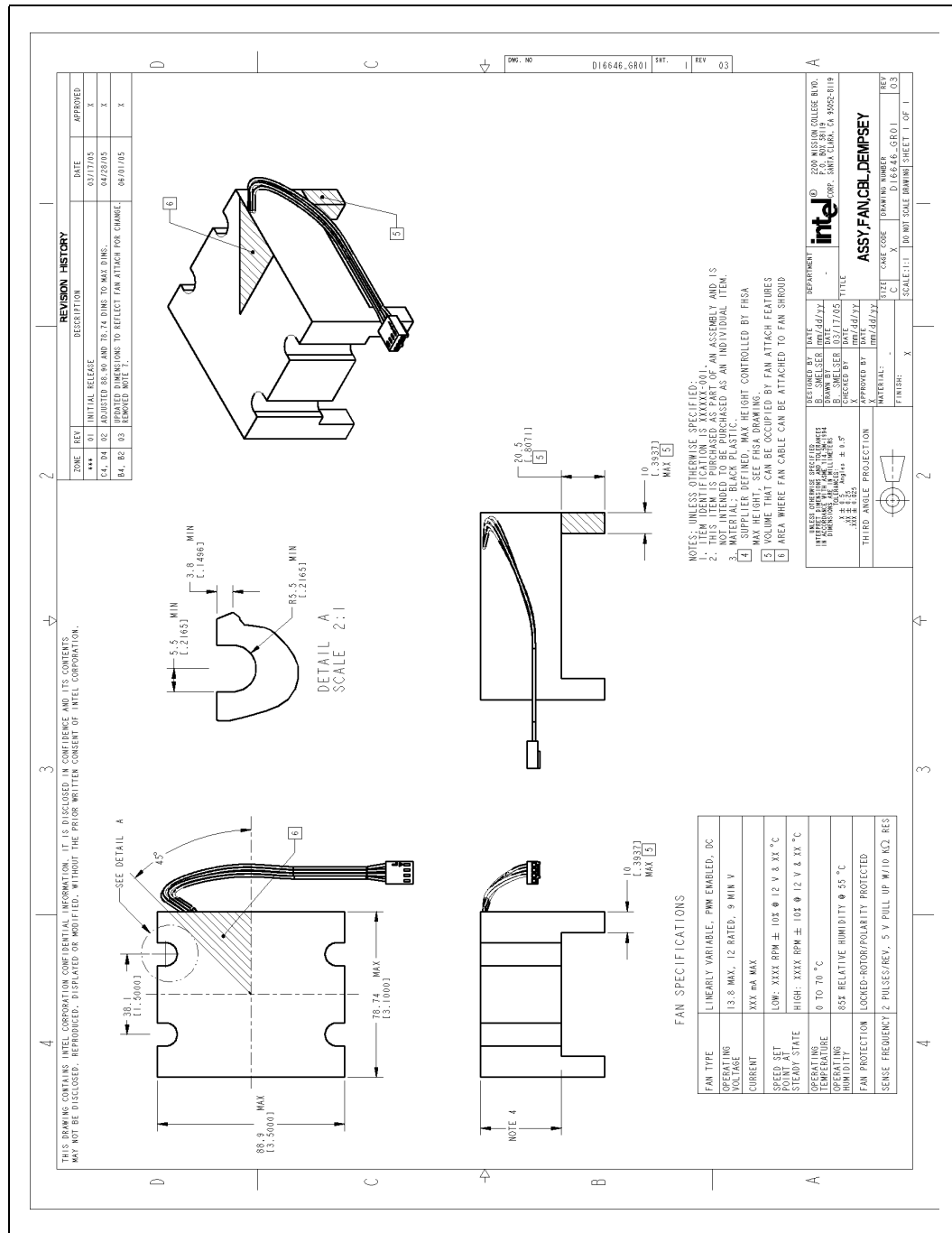


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Quad-Core Intel® Xeon® Processor 5400 Series TMDG



Figure B-19. Active CEK Thermal Solution Volumetric (Sheet 2 of 3)



Quad-Core Intel® Xeon® Processor 5400 Series TMDG



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NOTES:

- THIS DRAWING TO BE USED IN CORRELATION WITH SUPPLIED 3D DATABASE FILE. ALL DIMENSIONS AND TOLERANCES ON THIS DRAWING HAVE PRECEDENCE OVER SUPPLIED FILE.
- ALUMINUM 6063-T5 & 216 W/M-X MIN. FINISH. ALL DIMENSIONS ARE IN MILLIMETERS.
- EXTRUDED DIMENSIONS STATED IN INCHES.
- CRITICAL TO FUNCTION DIMENSION.
- REMOVE ALL BURRS OR SHARP EDGES.
- COOLING ZONE - 1.50MM TO 0.04" CENTER ON HEAT SINK BASE.
- HEAT SINK BASE FEATURES ARE SYMMETRIC ABOUT CENTER LINE.
- FIN THICKNESS : 0.9MM, DRAFT ANGLE : 0.3 DEGREE
- FIN SPACING : 3.4MM
- FIN FRAME OF THIS FEATURE IS CRITICAL TO THE INTERFERENCE PRESS FIT BETWEEN THE STANDOFF AND THE HEAT SINK BASE.
- SYMMETRIC FEATURES REQUIRED FOR CAPTIVE SCREW FUNCTIONALITY.
- SYMMETRIC FEATURES REQUIRED FOR CAPTIVE SCREW FUNCTIONALITY.
- MARK PART NUMBER IN ALLOWABLE AREA. EITHER SIDE OF THE PART CAN BE AN INK MARK, LASER MARK, PUNCH MARK OR ANY OTHER PERMANENT MARK THAT IS READABLE AT 1.0X MAGNIFICATION.

EXPLODED VIEW OF CEK HEAT SINK ASSEMBLY

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Quad-Core Intel® Xeon® Processor 5400 Series TMDG



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HEAT SINK ASSEMBLY DETAILS

DETAIL C
SCALE 6:1

USE STATE

SPRING MUST COLLAPSE INTO HOLE OF PIN HOLES

INTERFERENCE FIT - RE-ENTER HEAT SINK INTO HOLES AND PRESS FIT STANDOFF

0.115 (0.005)

0.406 (0.016)

0.710 (0.028)

0.340 (0.013)

DETAIL D
SCALE 6:1

AS SHIPPED STATE

0.406 (0.016)

0.710 (0.028)

SECTION B-B

SEE DETAIL C

SEE DETAIL D

DRAWING NUMBER: DT1537
DATE: 10-1-1980
SCALE: 10:1, 100 NOT SCALE DRAWING
SHEET: 3 OF 4
DEPARTMENT: PTH
THIS DRAWING COULD BE FOR A DIFFERENT DESIGN

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8 7 6 5 4 3 2 1

SECTION E-E

12 PHILLIPS HEAD

5.54 ± 0.09
[0.22 ± 0.00]

1.40 ± 0.05
[0.05]

6.32 EXTERNAL THREAD

6.32 INTERNAL THREAD

4.775 ± 0.026
[0.186 ± 0.000]

3.81 ± 0.13
[0.13]

6.35 ± 0.13
[0.13]

13.40 ± 0.13
[0.13]

9.61 ± 0.380
[0.380]

13.070 ± 0.151
[0.151]

LEE SPRING—
P/N 6 EQUIVALENT
OR EQUIVALENT

9.33 ± 0.383
[0.383]

2.13 ± 0.061
[0.061]

Ø 9.31 ± 0.011
[0.011]

9.31 ± 0.383
[0.383]

STAINLESS STEEL

STAINLESS STEEL

SECTION E-E

DEPARTMENT PTH

100% INSPECTION REQUIRED BY
P/N 6 QUAL. CA 94556-8-115

DATE 01/15/97

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SHEET 2 OF 2

COMPONENT DETAILS



§



C Heatsink Clip Load Methodology

C.1 Overview

This section describes a procedure for measuring the load applied by the heatsink/clip/fastener assembly on a processor package.

This procedure is recommended to verify the preload is within the design target range for a design, and in different situations. For example:

- Heatsink preload for the LGA771 socket.
- Quantify preload degradation under bake conditions.

Note: This document reflects the current metrology used by Intel. Intel is continuously exploring new ways to improve metrology. Updates will be provided later as this document is revised as appropriate.

C.2 Test Preparation

C.2.1 Heatsink Preparation

Three load cells are assembled into the base of the heatsink under test, in the area interfacing with the processor Integrated Heat Spreader (IHS), using load cells equivalent to those listed in [Section C.2.2](#).

To install the load cells, machine a pocket in the heatsink base, as shown in [Figure C-1](#) and [Figure C-2](#). The load cells should be distributed evenly, as close as possible to the pocket walls. Apply wax around the circumference of each load cell and the surface of the pocket around each cell to maintain the load cells in place during the heatsink installation on the processor and motherboard.

The depth of the pocket depends on the height of the load cell used for the test. It is necessary that the load cells protrude out of the heatsink base. However, this protrusion should be kept minimal, as it will create an additional load offset since the heatsink base is artificially raised. The measurement load offset depends on the whole assembly stiffness (i.e. motherboard, clip, fastener, etc.). For example, the Quad-Core Intel® Xeon® Processor 5400 Series CEK Reference Heatsink Design clip and fasteners assembly have a stiffness of around 160 N/mm [915 lb/in]. If the resulting protrusion is 0.038 mm [0.0015"], then an extra load of 6.08 N [1.37 lb] will be created, and will need to be subtracted from the measured load. [Figure C-3](#) shows an example using the Quad-Core Intel® Xeon® Processor 5400 Series CEK Reference Heatsink designed for the Quad-Core Intel® Xeon® Processor 5400 Series in the 771-land LGA package.

Note: When optimizing the heatsink pocket depth, the variation of the load cell height should also be taken into account to make sure that all load cells protrude equally from the heatsink base. It may be useful to screen the load cells prior to installation to minimize variation.

Alternate Heatsink Sample Preparation

As just mentioned, making sure that the load cells have minimum protrusion out of the heatsink base is paramount to meaningful results. An alternate method to make sure that the test setup will measure loads representative of the non-modified design is:

- Machine the pocket in the heatsink base to a depth such that the tips of the load cells are just flush with the heatsink base.
- Then machine back the heatsink base by around 0.25 mm [0.01"], so that the load cell tips protrude beyond the base.

Proceeding this way, the original stack height of the heatsink assembly should be preserved. This should not affect the stiffness of the heatsink significantly.

Figure C-1. Load Cell Installation in Machined Heatsink Base Pocket - Bottom View

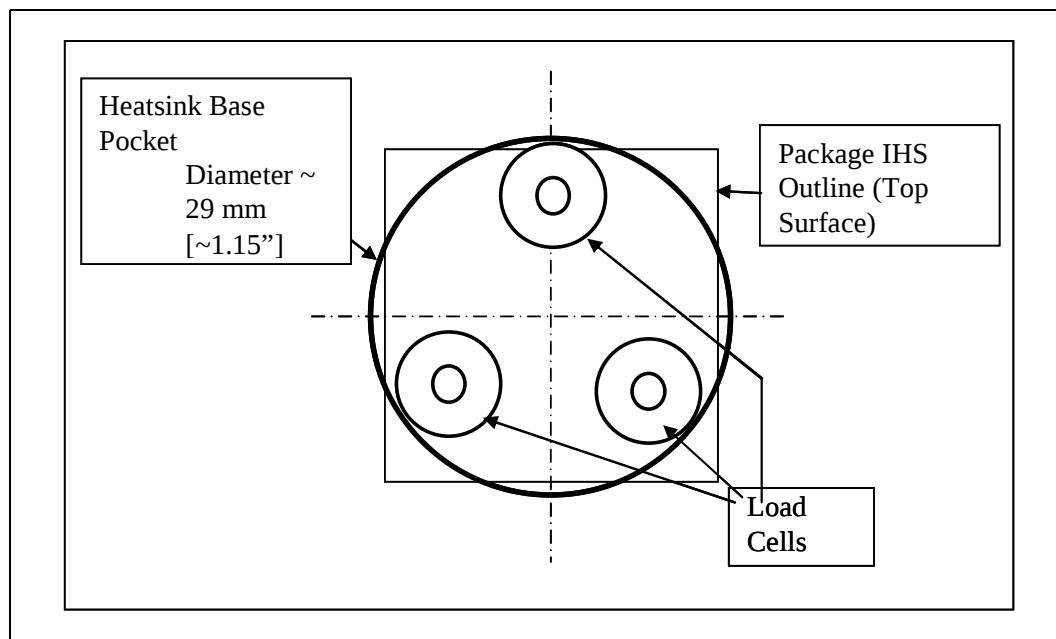


Figure C-2. Load Cell Installation in Machined Heatsink Base Pocket - Side View

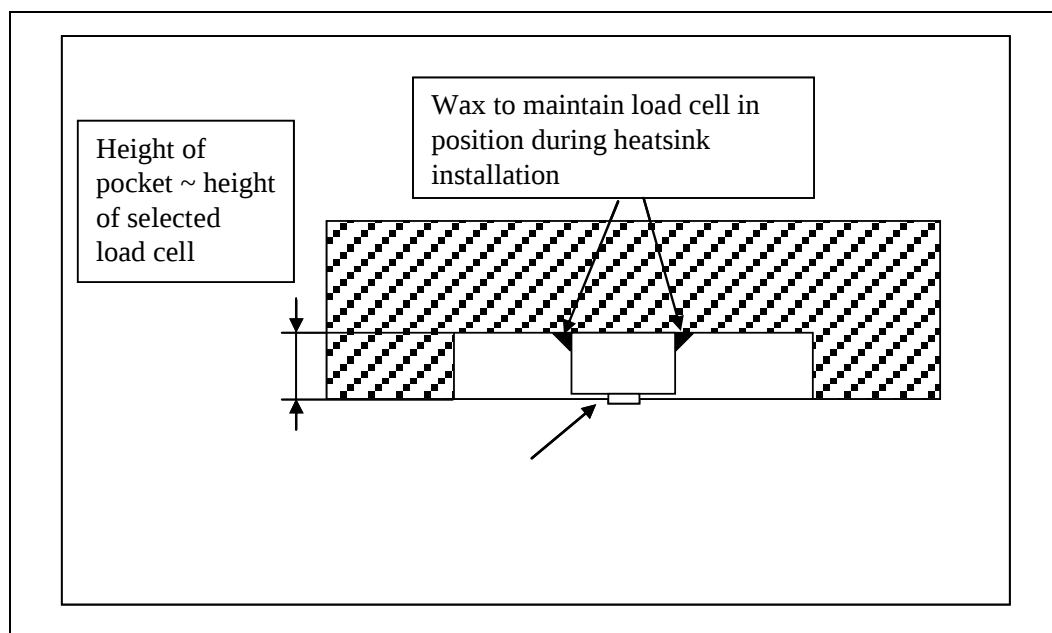
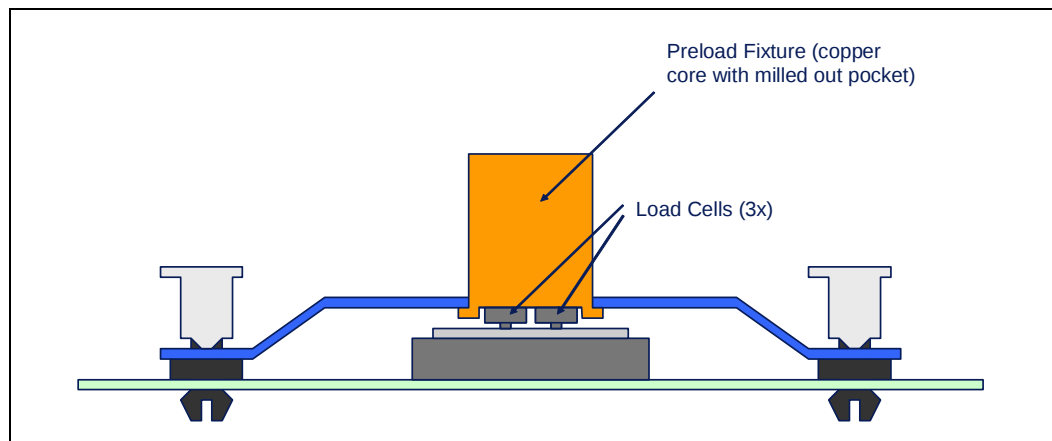


Figure C-3. Preload Test Configuration





C.2.2 Typical Test Equipment

For the heatsink clip load measurement, use equivalent test equipment to the one listed [Table C-1](#).

Table C-1. Typical Test Equipment

Item	Description	Part Number (Model)
Load cell Notes: 1, 5	Honeywell*-Sensotec* Model 13 subminiature load cells, compression only Select a load range depending on load level being tested. www.sensotec.com	AL322BL
Data Logger (or scanner) Notes: 2, 3, 4	Vishay* Measurements Group Model 6100 scanner with a 6010A strain card (one card required per channel).	Model 6100

Notes:

1. Select load range depending on expected load level. It is usually better, whenever possible, to operate in the high end of the load cell capability. Check with your load cell vendor for further information.
2. Since the load cells are calibrated in terms of mV/V, a data logger or scanner is required to supply 5 volts DC excitation and read the mV response. An automated model will take the sensitivity calibration of the load cells and convert the mV output into pounds.
3. With the test equipment listed above, it is possible to automate data recording and control with a 6101-PCI card (GPIB) added to the scanner, allowing it to be connected to a PC running LabVIEW* or Vishay's StrainSmart* software.
4. **IMPORTANT:** In addition to just a zeroing of the force reading at no applied load, it is important to calibrate the load cells against known loads. Load cells tend to drift. Contact your load cell vendor for calibration tools and procedure information.
5. When measuring loads under thermal stress (bake for example), load cell thermal capability must be checked, and the test setup must integrate any hardware used along with the load cell. For example, the Model 13 load cells are temperature compensated up to 71 °C, as long as the compensation package (spliced into the load cell's wiring) is also placed in the temperature chamber. The load cells can handle up to 121 °C (operating), but their uncertainty increases according to 0.02% rdg/°F.

C.2.3 Test Procedure Examples

The following sections give two examples of load measurement. However, this is not meant to be used in mechanical shock and vibration testing.

Any mechanical device used along with the heatsink attach mechanism will need to be included in the test setup (i.e., back plate, attach to chassis, etc.).

Prior to any test, make sure that the load cell has been calibrated against known loads, following load cell vendor's instructions.

C.2.4 Time-Zero, Room Temperature Preload Measurement

1. Pre-assemble mechanical components on the board as needed prior to mounting the motherboard on an appropriate support fixture that replicate the board attach to a target chassis.
For example: If the attach mechanism includes fixtures on the back side of the board, those must be included, as the goal of the test is to measure the load provided by the actual heatsink mechanism.
2. Install the test vehicle in the socket.
3. Assemble the heatsink reworked with the load cells to motherboard as shown for the Quad-Core Intel® Xeon® Processor 5400 Series CEK-reference heatsink example in [Figure C-3](#), and actuate attach mechanism.
4. Collect continuous load cell data at 1 Hz for the duration of the test. A minimum time to allow the load cell to settle is generally specified by the load cell vendors



(often on the order of 3 minutes). The time zero reading should be taken at the end of this settling time.

5. Record the preload measurement (total from all three load cells) at the target time and average the values over 10 seconds around this target time as well, i.e. in the interval for example over [target time – 5 seconds; target time + 5 seconds].

C.2.5 Preload Degradation under Bake Conditions

This section describes an example of testing for potential clip load degradation under bake conditions.

1. Preheat thermal chamber to target temperature (45 °C or 85 °C for example).
2. Repeat time-zero, room temperature preload measurement.
3. Place unit into preheated thermal chamber for specified time.
4. Record continuous load cell data as follows:
Sample rate = 0.1 Hz for first 3 hrs
Sample rate = 0.01 Hz for the remainder of the bake test
5. Remove assembly from thermal chamber and set into room temperature conditions
6. Record continuous load cell data for next 30 minutes at sample rate of 1 Hz.

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Heatsink Clip Load Methodology



D Safety Requirements

Heatsink and attachment assemblies shall be consistent with the manufacture of units that meet the safety standards:

1. UL Recognition-approved for flammability at the system level. All mechanical and thermal enabling components must be a minimum UL94V-2 approved.
2. CSA Certification. All mechanical and thermal enabling components must have CSA certification.
3. Heatsink fins must meet the test requirements of UL1439 for sharp edges.





Safety Requirements



E Quality and Reliability Requirements

E.1 Intel Verification Criteria for the Reference Designs

E.1.1 Reference Heatsink Thermal Verification

The Intel reference heatsinks will be verified within specific boundary conditions using a TTV and the methodology described in the *Intel® Xeon® Dual- and Multi- Processor Family Thermal Test Vehicle User's Guide*.

The test results, for a number of samples, are reported in terms of a worst-case mean + 3σ value for thermal characterization parameter using real processors (based on the TTV correction offset).

E.1.2 Environmental Reliability Testing

E.1.2.1 Structural Reliability Testing

The Intel reference heatsinks will be tested in an assembled condition, along with the LGA771 Socket. Details of the Environmental Requirements, and associated stress tests, can be found in the *LGA771 Socket Mechanical Design Guide*.

The use condition environment definitions provided in [Appendix E-1](#) are based on speculative use condition assumptions, and are provided as examples only.

Table E-1. Use Conditions Environment

Use Environment	Speculative Stress Condition		Example Use Condition	Example 7-Yr Stress Equiv.	Example 10-Yr Stress Equiv.
Shipping and Handling	Mechanical Shock - System-level - Unpackaged - Trapezoidal 25 g - velocity change is based on packaged weight		Total of 12 drops per system: 2 drops per axis ± direction	n/a	n/a
	Product Weight (lbs)	Non-palletized Product Velocity Change [†] (in/sec)			
	< 20 lbs 20 to > 40 40 to > 80 80 to < 100 100 to < 120 ≥120	250 225 205 175 145 125			
	[†] Change in velocity is based upon a 0.5 coefficient of restitution.				
Shipping and Handling	Random Vibration - System Level - Unpackaged 5 Hz to 500 Hz 2.20 g RMS random 5 Hz @ .001 g²/Hz to 20 Hz @ 0.01 g²/Hz (slope up) 20 Hz to 500 Hz @ 0.01 g²/Hz (flat) - Random control limit tolerance is ± 3 dB		Total per system: 10 minutes per axis 3 axes	n/a	n/a

Note: In the case of a discrepancy, information in the most recent *LGA771 Socket Mechanical Design Guidelines* supersedes that in the Table E-1 above.

E.1.2.2 Recommended Test Sequence

Each test sequence should start with components (i.e. baseboard, heatsink assembly, etc.) that have not been previously submitted to any reliability testing.

The test sequence should always start with a visual inspection after assembly, and BIOS/Processor/memory test. The stress test should be then followed by a visual inspection and then BIOS/Processor/memory test.

E.1.2.3 Post-Test Pass Criteria

The post-test pass criteria are:

1. No significant physical damage to the heatsink and retention hardware.
2. Heatsink remains seated and its bottom remains mated flatly against the IHS surface. No visible gap between the heatsink base and processor IHS. No visible tilt of the heatsink with respect to the retention hardware.



3. No signs of physical damage on baseboard surface due to impact of heatsink.
4. No visible physical damage to the processor package.
5. Successful BIOS/Processor/memory test of post-test samples.
6. Thermal compliance testing to demonstrate that the case temperature specification can be met.

E.1.2.4 Recommended BIOS/Processor/Memory Test Procedures

This test is to ensure proper operation of the product before and after environmental stresses, with the thermal mechanical enabling components assembled. The test shall be conducted on a fully operational baseboard that has not been exposed to any battery of tests prior to the test being considered.

Testing setup should include the following components, properly assembled and/or connected:

- Appropriate system baseboard.
- Processor and memory.
- All enabling components, including socket and thermal solution parts.

The pass criterion is that the system under test shall successfully complete the checking of BIOS, basic processor functions and memory, without any errors. *Intel PC Diags* is an example of software that can be utilized for this test.

E.1.3 Material and Recycling Requirements

Material shall be resistant to fungal growth. Examples of non-resistant materials include cellulose materials, animal and vegetable based adhesives, grease, oils, and many hydrocarbons. Synthetic materials such as PVC formulations, certain polyurethane compositions (e.g. polyester and some polyethers), plastics which contain organic fillers of laminating materials, paints, and varnishes also are susceptible to fungal growth. If materials are not fungal growth resistant, then MIL-STD-810E, Method 508.4 must be performed to determine material performance.

Material used shall not have deformation or degradation in a temperature life test.

Any plastic component exceeding 25 grams should be recyclable per the European Blue Angel recycling standards.

The following definitions apply to the use of the terms lead-free, Pb-free, and RoHS compliant.

Lead-free and Pb-free: Lead has not been intentionally added, but lead may still exist as an impurity below 1000 ppm.

RoHS compliant: Lead and other materials banned in RoHS Directive are either (1) below all applicable substance thresholds as proposed by the EU or (2) an approved/pending exemption applies.

Note: RoHS implementation details are not fully defined and may change.

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Quality and Reliability Requirements



F Enabled Suppliers Information

F.1 Supplier Information

F.1.1 Intel Enabled Suppliers

The Intel reference enabling solution for Quad-Core Intel® Xeon® Processor 5400 Series is preliminary. The Intel reference solutions have not been verified to meet the criteria outlined in [Appendix E](#). Customers can purchase the Intel reference thermal solution components from the suppliers listed in [Table F-1](#).

For additional details, please refer to the Quad-Core Intel® Xeon® Processor 5400 Series thermal mechanical enabling components drawings in [Appendix B](#).

Table F-1. Suppliers for the Quad-Core Intel® Xeon® Processor 5400 Series Intel Reference Solution (Sheet 1 of 2)

Assembly	Component	Description	Development Suppliers	Supplier Contact Info
CEK771-01-2U (for 2U, 2U+)	CEK Heatsink Intel Reference Heatsink p/n C61708 rev03 Intel Boxed Heatsink p/n D36871	Copper Fin, Copper Base includes PCM45F TIM+cover	Fujikura CNDA# 1242012 (stacked fin)	Fujikura America Ash Ooe a_ooe@fujikura.com 408-748-6991 Fujikura Taiwan Branch Yao-Hsien Huang yeohsien@fujikuratw.com.tw 886(2)8788-4959
	CEK Heatsink Intel Boxed Heatsink p/n D36871	Copper Fin, Copper Base includes PCM45F TIM+cover	Furukawa CNDA# 65755 (Crimped fin)	Tim Yu Yu@FurukawaAmerica.com 408-345-1520 Johnson Tseng Johnson@tfe.com.tw (02)2563-8148x15
	Thermal Interface Material	Grease	Shin-Etsu G751 CNDA 75610	Randy Isaacson risaacson@microsi.com (480) 893-8898x113
	CEK Spring for LGA771 socket Intel p/n D13646 rev04	Stainless Steel 301, Kapton* Tape on Reinforced Spring Fingers	AVC CNDA# AP5281	Steve Huang (APAC) +86-755-3366-8888 x66888 +86-138-252-45215 steve@avc.com.cn Huabin Chen (China Only) +886-755-3366-8888 x66871 huabin@avc.com.cn
	CEK Spring for LGA771 socket Intel p/n D13646 rev04	Stainless Steel 301, Kapton* Tape on Reinforced Spring Fingers	ITW Fastex CNDA# 78538	Roger Knell rknell@itwfastex.com 773-307-9035 Henry Lu henry@mail.itwasia.com.tw 886-7-881-9206x10

**Table F-1. Suppliers for the Quad-Core Intel® Xeon® Processor 5400 Series Intel Reference Solution (Sheet 2 of 2)**

Assembly	Component	Description	Development Suppliers	Supplier Contact Info
CEK771-01-1U (for 1U)	CEK Heatsink Intel p/n C90546 rev02	Copper Fin, Copper Base	Fujikura CNDA# 1242012 (stacked fin)	Fujikura America Ash Ooe a_ooe@fujikura.com 408-748-6991 Fujikura Taiwan Branch Yao-Hsien Huang yeohsien@fujikuratw.com.tw 886(2)8788-4959
	Thermal Interface Material	See CEK771-01-2U		
	CEK Spring for CEK771	See CEK771-01-2U		
CEK771-02-1U (for 1U)	CEK Low Cost Heatsink for Mid and Low Power SKUs Intel p/n D71537 Rev 02	Aluminum Extrusion	Asia Vital Components (AVC) CNDA# AP5281	Steve Huang (APAC) +86-755-3366-8888 x66888 +86-138-252-45215 steve@avc.com.cn Huabin Chen (China Only) +886-755-3366-8888 x66871 huabin@avc.com.cn
	Thermal Interface Material	See CEK771-01-2U		
	CEK Spring for CEK771	See CEK771-01-2U		

Note: CEK771-02-1U is the 1U alternative reference heatsink design for Quad-Core Intel® Xeon® Processor E5400 Series in volumetrically constrained form factors.

F.1.2 Additional Suppliers

The Intel enabled solutions for Quad-Core Intel® Xeon® Processor 5400 Series are preliminary. The Intel enabled solutions have not been verified to meet the criteria outlined in [Appendix E](#). Customers can purchase the Intel enabled thermal solution components from the suppliers listed in [Table F-1](#) and [Table F-2](#).

For additional details, please refer to the Quad-Core Intel® Xeon® Processor 5400 Series thermal mechanical enabling components drawings in [Appendix B](#).



Table F-2. Additional Suppliers for the Quad-Core Intel® Xeon® Processor 5400 Series Intel Reference Solution (Sheet 1 of 2)

Assembly	Component	Description	Development Suppliers	Supplier Contact Info
2U Heatsink	Alternative CEK Heatsink	Copper Fin, Copper Base	Aavid Thermalloy CNDA#2525071	David Huang huang@aavid.com 603-223-1724 Frank Hsue frank.hsu@aavid.com.tw 886-2-26989888 x306
		Copper Fin, Copper Base - and - Aluminum	ADDA Corporation CNDA#AP1249	Jungpin Chen jungpin@adda.com.tw 886-2-82212252x232
		Copper Fin, Copper Base - and - Aluminum	Asia Vital Components (AVC) CNDA# AP5281	Steve Huang (APAC) +86-755-3366-8888 x66888 +86-138-252-45215 steve@avc.com.cn Huabin Chen (China Only) +886-755-3366-8888 x66871 huabin@avc.com.cn
		Copper Fin, Copper Base - and - Aluminum	Auras CNDA#5779699	Ian Shih liverpool@auras.com.tw +886-937-183-194
		Copper Fin, Copper Base - and - Aluminum	CCI (Chaun-Choung Technology Co. Ltd.) CNDA#8747572	Monica Chih monica_chih@ccic.com.tw 8862-29952666 EXT 292 Harry Lin 714-739-5797 ackinc@aol.com
		Aluminum	CoolJag (Chia Cherne Industry Co., Ltd.)	Alice Yang +886-4-7323090 alice@cooljag.com Kenny Kwang 510-824-0888 kenny@cooljagusa.com
		Copper Fin, Copper Base	CoolerMaster CNDA#7425225	Helena Wen helena_wen@collermaster.com.tw +886-2-3234-0050x235
		Copper Fin, Copper Base - and - Aluminum	Taisol Electronics CNDA #3434254	Jane Yui jane.yui@taisol.com.tw +886-2-2656-2658 x113
		Copper Fin, Copper Base	Thermaltake CNDA#7429482	Vera Lee vera@thermaltake.com +886-2-2662-6501-255



Table F-2. Additional Suppliers for the Quad-Core Intel® Xeon® Processor 5400 Series Intel Reference Solution (Sheet 2 of 2)

Assembly	Component	Description	Development Suppliers	Supplier Contact Info
1U Heatsink	Alternative CEK Heatsink	Copper Fin, Copper Base	Aavid Thermalloy CNDA#2525071	David Huang huang@aavid.com 603-223-1724 Frank Hsue frank.hsu@aavid.com.tw 886-2-26989888 x306
		Copper Fin, Copper Base - and - Aluminum	ADDA CNDA# AP1249	Jungpin Chen jungpin@adda.com.tw 886-2-82212252-232
		Copper Fin, Copper Base - and - Aluminum	Asia Vital Components (AVC) CNDA# AP5281	Steve Huang (APAC) +86-755-3366-8888 x66888 +86-138-252-45215 steve@avc.com.cn Huabin Chen (China Only) +886-755-3366-8888 x66871 huabin@avc.com.cn
		Copper Fin, Copper Base - and - Aluminum	Auras CNDA#5779699	Ian Shih liverpool@auras.com.tw 886-2-89901653 x314
		Copper Fin, Copper Base - and - Aluminum	CCI (Chaun-Choung Technology Co. Ltd.) CNDA# 8747572	Monica Chih monica_chih@ccic.com.tw 886-2-29952666x292 Harry Lin ackinc@aol.com 714-739-5797
		Aluminum	CoolJag (Chia Cherne Industry Co., Ltd.)	Alice Yang +886-4-7323090 alice@cooljag.com Kenny Kwang 510-824-0888 kenny@cooljagusa.com
		Copper Fin, Copper Base	CoolerMaster CNDA#7425225	Helena Wen helena_wen@collermaster.com.tw +886-2-3234-0050x235
		Copper Fin, Copper Base - and - Aluminum	Molex CNDA#11277	Aljo Amorelli Aljo.Amorelli@molex.com 630-718-5919 Jeremy Shen +886-2-26202300-459 +886-926132586
		Copper Fin, Copper Base - and - Aluminum	Taisol Electronics CNDA #3434254	Jane Yui jane.yui@taisol.com.tw +886-2-2656-2658 x113
		Copper Fin, Copper Base - and - Aluminum	Thermaltake CNDA#7429482	Vera Lee vera@thermaltake.com +886-2-2662-6501-255





Enabled Suppliers Information